



**CY7C1161V18, CY7C1176V18  
CY7C1163V18, CY7C1165V18**

## 18-Mbit QDR™-II+ SRAM 4-Word Burst Architecture (2.5 Cycle Read Latency)

### Features

- Separate independent read and write data ports
  - Supports concurrent transactions
- 300 MHz to 400 MHz clock for high bandwidth
- 4-word burst to reduce address bus frequency
- Double Data Rate (DDR) interfaces on both read and write ports (data transferred at 800 MHz) at 400 MHz
- Read latency of 2.5 clock cycles
- Two input clocks (K and  $\bar{K}$ ) for precise DDR timing
  - SRAM uses rising edges only
- Echo clocks (CQ and  $\bar{CQ}$ ) simplify data capture in high speed systems
- Single multiplexed address input bus latches address inputs for both read and write ports
- Separate port selects for depth expansion
- Data valid pin (QVLD) to indicate valid data on the output
- Synchronous internally self-timed writes
- Available in x8, x9, x18, and x36 configurations
- Full data coherency providing most current data
- Core  $V_{DD} = 1.8V \pm 0.1V$ ; IO  $V_{DDQ} = 1.4V$  to  $V_{DD}$ <sup>[1]</sup>
- Available in 165-ball FBGA package (13 x 15 x 1.4 mm)
- Offered in both Pb-free and non Pb-free packages
- Variable drive HSTL output buffers
- JTAG 1149.1 compatible test access port
- Delay Lock Loop (DLL) for accurate data placement

### Configurations

With cycle read latency of 2.5 cycles:

CY7C1161V18 – 2M x 8  
CY7C1176V18 – 2M x 9  
CY7C1163V18 – 1M x 18  
CY7C1165V18 – 512K x 36

### Selection Guide

| Description                 | 400 MHz | 375 MHz | 333 MHz | 300 MHz | Unit |
|-----------------------------|---------|---------|---------|---------|------|
| Maximum Operating Frequency | 400     | 375     | 333     | 300     | MHz  |
| Maximum Operating Current   | 1080    | 1020    | 920     | 850     | mA   |

#### Note

1. The QDR consortium specification for  $V_{DDQ}$  is  $1.5V \pm 0.1V$ . The Cypress QDR devices exceed the QDR consortium specification and are capable of supporting  $V_{DDQ} = 1.4V$  to  $V_{DD}$ .

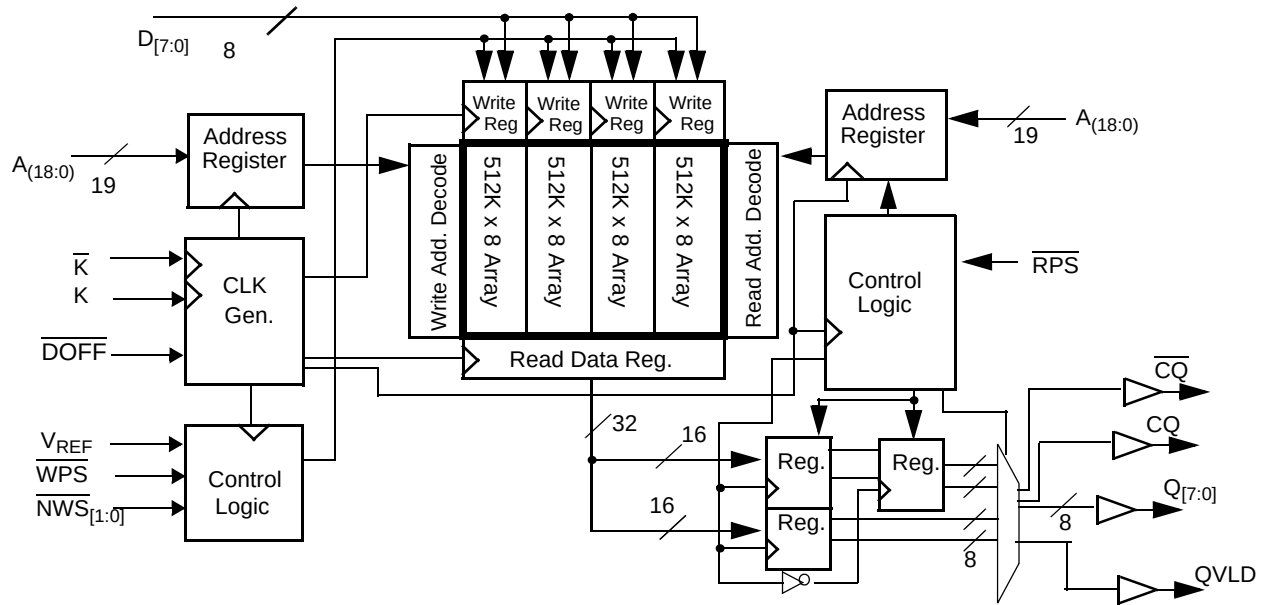
### Functional Description

The CY7C1161V18, CY7C1176V18, CY7C1163V18, and CY7C1165V18 are 1.8V Synchronous Pipelined SRAMs equipped with QDR™-II+ architecture. QDR-II+ architecture consists of two separate ports to access the memory array. The read port has dedicated data outputs to support read operations and the write port has dedicated data inputs to support write operations. QDR-II+ architecture has separate data inputs and data outputs to completely eliminate the need to turn around the data bus that is required with common IO devices. Each port can be accessed through a common address bus. Addresses for read and write addresses are latched onto alternate rising edges of the input (K) clock. Accesses to the QDR-II+ read and write ports are completely independent of one another. In order to maximize data throughput, both read and write ports are equipped with Double Data Rate (DDR) interfaces. Each address location is associated with four 8-bit words (CY7C1161V18), 9-bit words (CY7C1176V18), 18-bit words (CY7C1163V18), or 36-bit words (CY7C1165V18) that burst sequentially into or out of the device. Because data can be transferred into and out of the device on every rising edge of both input clocks K and  $\bar{K}$ , memory bandwidth is maximized while simplifying system design by eliminating bus turnarounds.

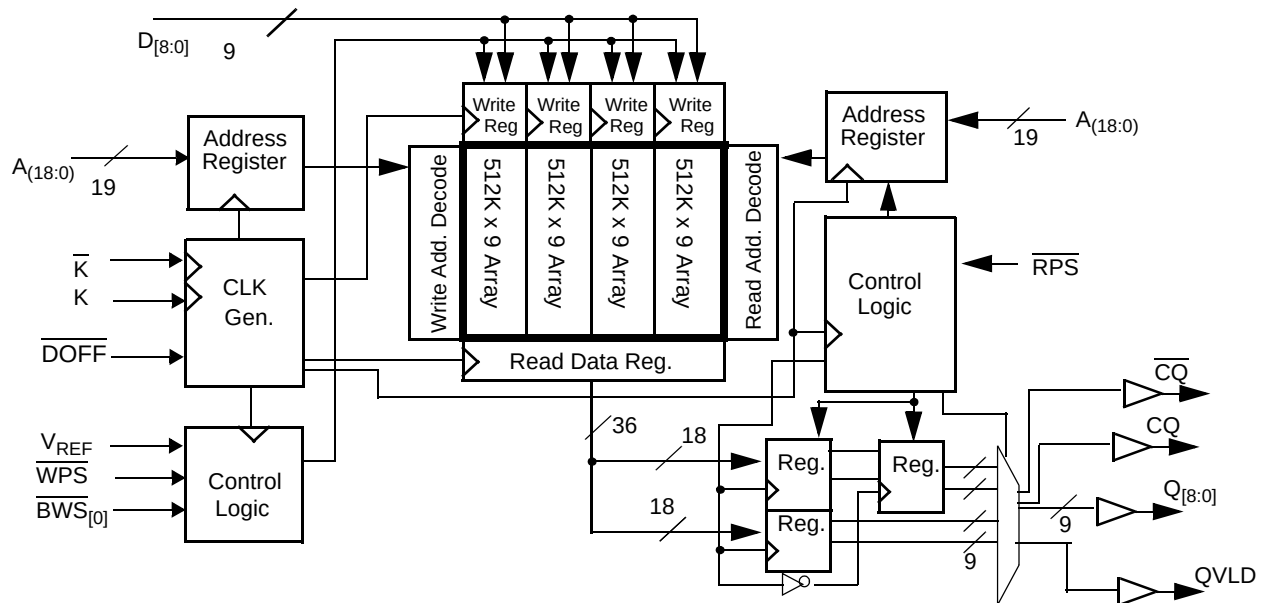
Depth expansion is accomplished with port selects for each port. Port selects allow each port to operate independently.

All synchronous inputs pass through input registers controlled by the K or  $\bar{K}$  input clocks. All data outputs pass through output registers controlled by the K or  $\bar{K}$  input clocks. Writes are conducted with on-chip synchronous self-timed write circuitry.

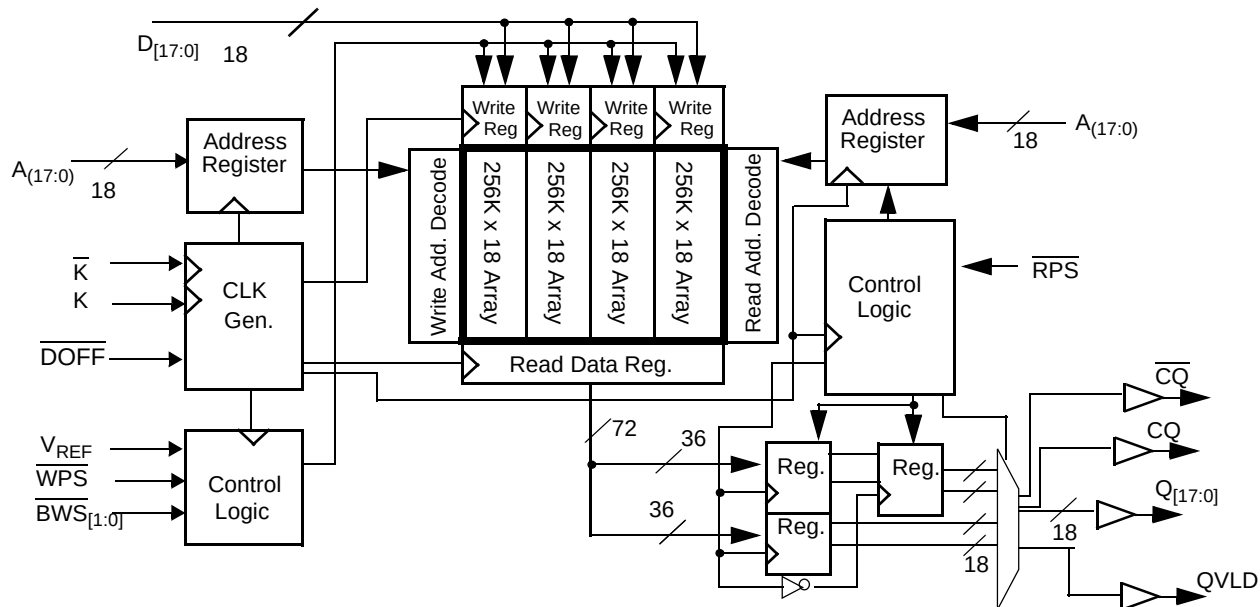
## Logic Block Diagram (CY7C1161V18)



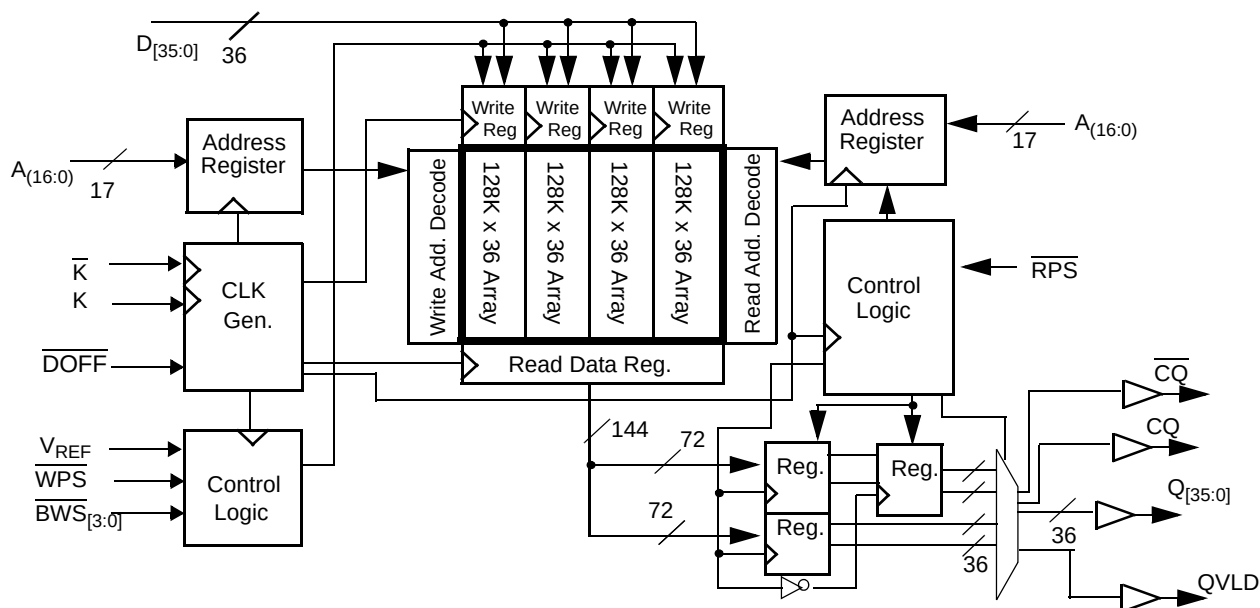
## Logic Block Diagram (CY7C1176V18)



### Logic Block Diagram (CY7C1163V18)



### Logic Block Diagram (CY7C1165V18)



## Pin Configurations

### 165-Ball FBGA (13 x 15 x 1.4 mm) Pinout

#### CY7C1161V18 (2M x 8)

|          | 1                        | 2         | 3         | 4                       | 5                         | 6                     | 7                         | 8                       | 9         | 10        | 11  |
|----------|--------------------------|-----------|-----------|-------------------------|---------------------------|-----------------------|---------------------------|-------------------------|-----------|-----------|-----|
| <b>A</b> | $\overline{\text{CQ}}$   | NC/72M    | A         | $\overline{\text{WPS}}$ | $\overline{\text{NWS}}_1$ | $\overline{\text{K}}$ | NC/144M                   | $\overline{\text{RPS}}$ | A         | NC/36M    | CQ  |
| <b>B</b> | NC                       | NC        | NC        | A                       | NC/288M                   | K                     | $\overline{\text{NWS}}_0$ | A                       | NC        | NC        | Q3  |
| <b>C</b> | NC                       | NC        | NC        | $V_{SS}$                | A                         | NC                    | A                         | $V_{SS}$                | NC        | NC        | D3  |
| <b>D</b> | NC                       | D4        | NC        | $V_{SS}$                | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{SS}$                | NC        | NC        | NC  |
| <b>E</b> | NC                       | NC        | Q4        | $V_{DDQ}$               | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{DDQ}$               | NC        | D2        | Q2  |
| <b>F</b> | NC                       | NC        | NC        | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | NC        | NC  |
| <b>G</b> | NC                       | D5        | Q5        | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | NC        | NC  |
| <b>H</b> | $\overline{\text{DOFF}}$ | $V_{REF}$ | $V_{DDQ}$ | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | $V_{DDQ}$ | $V_{REF}$ | ZQ  |
| <b>J</b> | NC                       | NC        | NC        | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | Q1        | D1  |
| <b>K</b> | NC                       | NC        | NC        | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | NC        | NC  |
| <b>L</b> | NC                       | Q6        | D6        | $V_{DDQ}$               | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{DDQ}$               | NC        | NC        | Q0  |
| <b>M</b> | NC                       | NC        | NC        | $V_{SS}$                | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{SS}$                | NC        | NC        | D0  |
| <b>N</b> | NC                       | D7        | NC        | $V_{SS}$                | A                         | A                     | A                         | $V_{SS}$                | NC        | NC        | NC  |
| <b>P</b> | NC                       | NC        | Q7        | A                       | A                         | QVLD                  | A                         | A                       | NC        | NC        | NC  |
| <b>R</b> | TDO                      | TCK       | A         | A                       | A                         | NC                    | A                         | A                       | A         | TMS       | TDI |

#### CY7C1176V18 (2M x 9)

|          | 1                        | 2         | 3         | 4                       | 5        | 6                     | 7                         | 8                       | 9         | 10        | 11  |
|----------|--------------------------|-----------|-----------|-------------------------|----------|-----------------------|---------------------------|-------------------------|-----------|-----------|-----|
| <b>A</b> | $\overline{\text{CQ}}$   | NC/72M    | A         | $\overline{\text{WPS}}$ | NC       | $\overline{\text{K}}$ | NC/144M                   | $\overline{\text{RPS}}$ | A         | NC/36M    | CQ  |
| <b>B</b> | NC                       | NC        | NC        | A                       | NC/288M  | K                     | $\overline{\text{BWS}}_0$ | A                       | NC        | NC        | Q4  |
| <b>C</b> | NC                       | NC        | NC        | $V_{SS}$                | A        | NC                    | A                         | $V_{SS}$                | NC        | NC        | D4  |
| <b>D</b> | NC                       | D5        | NC        | $V_{SS}$                | $V_{SS}$ | $V_{SS}$              | $V_{SS}$                  | $V_{SS}$                | NC        | NC        | NC  |
| <b>E</b> | NC                       | NC        | Q5        | $V_{DDQ}$               | $V_{SS}$ | $V_{SS}$              | $V_{SS}$                  | $V_{DDQ}$               | NC        | D3        | Q3  |
| <b>F</b> | NC                       | NC        | NC        | $V_{DDQ}$               | $V_{DD}$ | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | NC        | NC  |
| <b>G</b> | NC                       | D6        | Q6        | $V_{DDQ}$               | $V_{DD}$ | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | NC        | NC  |
| <b>H</b> | $\overline{\text{DOFF}}$ | $V_{REF}$ | $V_{DDQ}$ | $V_{DDQ}$               | $V_{DD}$ | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | $V_{DDQ}$ | $V_{REF}$ | ZQ  |
| <b>J</b> | NC                       | NC        | NC        | $V_{DDQ}$               | $V_{DD}$ | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | Q2        | D2  |
| <b>K</b> | NC                       | NC        | NC        | $V_{DDQ}$               | $V_{DD}$ | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | NC        | NC  |
| <b>L</b> | NC                       | Q7        | D7        | $V_{DDQ}$               | $V_{SS}$ | $V_{SS}$              | $V_{SS}$                  | $V_{DDQ}$               | NC        | NC        | Q1  |
| <b>M</b> | NC                       | NC        | NC        | $V_{SS}$                | $V_{SS}$ | $V_{SS}$              | $V_{SS}$                  | $V_{SS}$                | NC        | NC        | D1  |
| <b>N</b> | NC                       | D8        | NC        | $V_{SS}$                | A        | A                     | A                         | $V_{SS}$                | NC        | NC        | NC  |
| <b>P</b> | NC                       | NC        | Q8        | A                       | A        | QVLD                  | A                         | A                       | NC        | D0        | Q0  |
| <b>R</b> | TDO                      | TCK       | A         | A                       | A        | NC                    | A                         | A                       | A         | TMS       | TDI |

**Pin Configurations** (continued)

**165-Ball FBGA (13 x 15 x 1.4 mm) Pinout**

**CY7C1163V18 (1M x 18)**

|          | 1                        | 2         | 3         | 4                       | 5                         | 6                     | 7                         | 8                       | 9         | 10        | 11  |
|----------|--------------------------|-----------|-----------|-------------------------|---------------------------|-----------------------|---------------------------|-------------------------|-----------|-----------|-----|
| <b>A</b> | $\overline{\text{CQ}}$   | NC/144M   | NC/36M    | $\overline{\text{WPS}}$ | $\overline{\text{BWS}}_1$ | $\overline{\text{K}}$ | NC/288M                   | $\overline{\text{RPS}}$ | A         | NC/72M    | CQ  |
| <b>B</b> | NC                       | Q9        | D9        | A                       | NC                        | K                     | $\overline{\text{BWS}}_0$ | A                       | NC        | NC        | Q8  |
| <b>C</b> | NC                       | NC        | D10       | $V_{SS}$                | A                         | NC                    | A                         | $V_{SS}$                | NC        | Q7        | D8  |
| <b>D</b> | NC                       | D11       | Q10       | $V_{SS}$                | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{SS}$                | NC        | NC        | D7  |
| <b>E</b> | NC                       | NC        | Q11       | $V_{DDQ}$               | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{DDQ}$               | NC        | D6        | Q6  |
| <b>F</b> | NC                       | Q12       | D12       | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | NC        | Q5  |
| <b>G</b> | NC                       | D13       | Q13       | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | NC        | D5  |
| <b>H</b> | $\overline{\text{DOFF}}$ | $V_{REF}$ | $V_{DDQ}$ | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | $V_{DDQ}$ | $V_{REF}$ | ZQ  |
| <b>J</b> | NC                       | NC        | D14       | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | Q4        | D4  |
| <b>K</b> | NC                       | NC        | Q14       | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | NC        | D3        | Q3  |
| <b>L</b> | NC                       | Q15       | D15       | $V_{DDQ}$               | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{DDQ}$               | NC        | NC        | Q2  |
| <b>M</b> | NC                       | NC        | D16       | $V_{SS}$                | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{SS}$                | NC        | Q1        | D2  |
| <b>N</b> | NC                       | D17       | Q16       | $V_{SS}$                | A                         | A                     | A                         | $V_{SS}$                | NC        | NC        | D1  |
| <b>P</b> | NC                       | NC        | Q17       | A                       | A                         | QVLD                  | A                         | A                       | NC        | D0        | Q0  |
| <b>R</b> | TDO                      | TCK       | A         | A                       | A                         | NC                    | A                         | A                       | A         | TMS       | TDI |

**CY7C1165V18 (512K x 36)**

|          | 1                        | 2         | 3         | 4                       | 5                         | 6                     | 7                         | 8                       | 9         | 10        | 11  |
|----------|--------------------------|-----------|-----------|-------------------------|---------------------------|-----------------------|---------------------------|-------------------------|-----------|-----------|-----|
| <b>A</b> | $\overline{\text{CQ}}$   | NC/288M   | NC/72M    | $\overline{\text{WPS}}$ | $\overline{\text{BWS}}_2$ | $\overline{\text{K}}$ | $\overline{\text{BWS}}_1$ | $\overline{\text{RPS}}$ | NC/36M    | NC/144M   | CQ  |
| <b>B</b> | Q27                      | Q18       | D18       | A                       | $\overline{\text{BWS}}_3$ | K                     | $\overline{\text{BWS}}_0$ | A                       | D17       | Q17       | Q8  |
| <b>C</b> | D27                      | Q28       | D19       | $V_{SS}$                | A                         | NC                    | A                         | $V_{SS}$                | D16       | Q7        | D8  |
| <b>D</b> | D28                      | D20       | Q19       | $V_{SS}$                | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{SS}$                | Q16       | D15       | D7  |
| <b>E</b> | Q29                      | D29       | Q20       | $V_{DDQ}$               | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{DDQ}$               | Q15       | D6        | Q6  |
| <b>F</b> | Q30                      | Q21       | D21       | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | D14       | Q14       | Q5  |
| <b>G</b> | D30                      | D22       | Q22       | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | Q13       | D13       | D5  |
| <b>H</b> | $\overline{\text{DOFF}}$ | $V_{REF}$ | $V_{DDQ}$ | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | $V_{DDQ}$ | $V_{REF}$ | ZQ  |
| <b>J</b> | D31                      | Q31       | D23       | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | D12       | Q4        | D4  |
| <b>K</b> | Q32                      | D32       | Q23       | $V_{DDQ}$               | $V_{DD}$                  | $V_{SS}$              | $V_{DD}$                  | $V_{DDQ}$               | Q12       | D3        | Q3  |
| <b>L</b> | Q33                      | Q24       | D24       | $V_{DDQ}$               | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{DDQ}$               | D11       | Q11       | Q2  |
| <b>M</b> | D33                      | Q34       | D25       | $V_{SS}$                | $V_{SS}$                  | $V_{SS}$              | $V_{SS}$                  | $V_{SS}$                | D10       | Q1        | D2  |
| <b>N</b> | D34                      | D26       | Q25       | $V_{SS}$                | A                         | A                     | A                         | $V_{SS}$                | Q10       | D9        | D1  |
| <b>P</b> | Q35                      | D35       | Q26       | A                       | A                         | QVLD                  | A                         | A                       | Q9        | D0        | Q0  |
| <b>R</b> | TDO                      | TCK       | A         | A                       | A                         | NC                    | A                         | A                       | A         | TMS       | TDI |

## Pin Definitions

| Pin Name                                                                 | IO                     | Pin Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
|--------------------------------------------------------------------------|------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $D_{[x:0]}$                                                              | Input-Synchronous      | <b>Data Input Signals.</b> Sampled on the rising edge of K and $\bar{K}$ clocks during valid write operations.<br>CY7C1161V18 – $D_{[7:0]}$<br>CY7C1176V18 – $D_{[8:0]}$<br>CY7C1163V18 – $D_{[17:0]}$<br>CY7C1165V18 – $D_{[35:0]}$                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| $\overline{WPS}$                                                         | Input-Synchronous      | <b>Write Port Select – Active LOW.</b> Sampled on the rising edge of the K clock. When asserted active, a write operation is initiated. Deasserting deselects the write port. Deselecting the write port causes $D_{[x:0]}$ to be ignored.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
| $\overline{NWS}_0, \overline{NWS}_1$                                     | Input-Synchronous      | <b>Nibble Write Select 0, 1 – Active LOW (CY7C1161V18 Only).</b> Sampled on the rising edge of the K and $\bar{K}$ clocks during Write operations. Used to select the nibble that is written into the device. $\overline{NWS}_0$ controls $D_{[3:0]}$ and $\overline{NWS}_1$ controls $D_{[7:4]}$ .<br>All the nibble write selects are sampled on the same edge as the data. Deselecting a nibble write select causes the corresponding nibble of data to be ignored and not written into the device.                                                                                                                                                                                                                                                                                                                                                   |
| $\overline{BWS}_0, \overline{BWS}_1, \overline{BWS}_2, \overline{BWS}_3$ | Input-Synchronous      | <b>Byte Write Select 0, 1, 2, and 3 – Active LOW.</b> Sampled on the rising edge of the K and $\bar{K}$ clocks during write operations. Used to select the byte that is written into the device during the current portion of the write operation. Bytes not written remain unaltered.<br>CY7C1176V18 – $\overline{BWS}_0$ controls $D_{[8:0]}$ .<br>CY7C1163V18 – $\overline{BWS}_0$ controls $D_{[8:0]}$ and $\overline{BWS}_1$ controls $D_{[17:9]}$ .<br>CY7C1165V18 – $\overline{BWS}_0$ controls $D_{[8:0]}$ , $\overline{BWS}_1$ controls $D_{[17:9]}$ , $\overline{BWS}_2$ controls $D_{[26:18]}$ , and $\overline{BWS}_3$ controls $D_{[35:27]}$ .<br>All the Byte Write Selects are sampled on the same edge as the data. Deselecting a Byte Write Select causes the corresponding byte of data to be ignored and not written into the device. |
| A                                                                        | Input-Synchronous      | <b>Address Inputs.</b> Sampled on the rising edge of the K clock during active read and write operations. These address inputs are multiplexed for both read and write operations. Internally, the device is organized as 2M x 8 (4 arrays each of 512K x 8) for CY7C1161V18, 2M x 9 (4 arrays each of 512K x 9) for CY7C1176V18, 1M x 18 (4 arrays each of 256K x 18) for CY7C1163V18, and 512K x 36 (4 arrays each of 128K x 36) for CY7C1165V18. Therefore, only 19 address inputs are needed to access the entire memory array of CY7C1161V18 and CY7C1176V18, 18 address inputs for CY7C1163V18, and 17 address inputs for CY7C1165V18. These inputs are ignored when the appropriate port is deselected.                                                                                                                                           |
| $Q_{[x:0]}$                                                              | Outputs-Synchronous    | <b>Data Output Signals.</b> These pins drive out the requested data during a read operation. Valid data is driven out on the rising edge of both the K and $\bar{K}$ clocks during read operations or K and $\bar{K}$ when in single clock mode. When the read port is deselected, $Q_{[x:0]}$ are automatically tri-stated.<br>CY7C1161V18 – $Q_{[7:0]}$ .<br>CY7C1176V18 – $Q_{[8:0]}$ .<br>CY7C1163V18 – $Q_{[17:0]}$ .<br>CY7C1165V18 – $Q_{[35:0]}$ .                                                                                                                                                                                                                                                                                                                                                                                               |
| $\overline{RPS}$                                                         | Input-Synchronous      | <b>Read Port Select – Active LOW.</b> Sampled on the rising edge of positive input clock (K). When active, a read operation is initiated. Deasserting causes the read port to be deselected. When deselected, the pending access is enabled to complete and the output drivers are automatically tri-stated following the next rising edge of the K clock. Each read access consists of a burst of four sequential transfers.                                                                                                                                                                                                                                                                                                                                                                                                                            |
| QVLD                                                                     | Valid Output Indicator | <b>Valid Output Indicator.</b> Indicates valid output data. QVLD is edge-aligned with CQ and $\bar{CQ}$ .                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
| K                                                                        | Input-Clock            | <b>Positive Input Clock Input.</b> Rising edge of K is used to capture synchronous inputs to the device and to drive out data through $Q_{[x:0]}$ when in single clock mode. All accesses are initiated on the rising edge of K.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
| $\bar{K}$                                                                | Input-Clock            | <b>Negative Input Clock Input.</b> $\bar{K}$ is used to capture synchronous inputs presented to the device and to drive out data through $Q_{[x:0]}$ when in single clock mode.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| CQ                                                                       | Echo Clock             | <b>Synchronous Echo Clock Outputs.</b> This is a free running clock and is synchronized to the input clock (K) of the QDR-II+. The timings for the echo clocks are shown in “Switching Characteristics” on page 23.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |

## Pin Definitions (continued)

| Pin Name          | IO              | Pin Description                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
|-------------------|-----------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $\overline{CQ}$   | Echo Clock      | <b>Synchronous Echo Clock Outputs.</b> This is a free running clock and is synchronized to the input clock ( $\overline{K}$ ) of the QDR-II+. The timings for the echo clocks are shown in <a href="#">"Switching Characteristics"</a> on page 23.                                                                                                                                                                                                                |
| ZQ                | Input           | <b>Output Impedance Matching Input.</b> Used to tune the device outputs to the system data bus impedance. $CQ$ , $\overline{CQ}$ and $Q_{[x:0]}$ output impedance are set to $0.2 \times RQ$ , where $RQ$ is a resistor connected between ZQ and ground. Alternatively, this pin is connected directly to $V_{DDQ}$ , which enables the minimum impedance mode. This pin cannot be connected directly to GND or left unconnected.                                 |
| $\overline{DOFF}$ | Input           | <b>DLL Turn Off – Active LOW.</b> Connecting this pin to ground turns off the DLL inside the device. The timings in the DLL turned-off operation are different from those listed in this data sheet. For normal operation, this pin is connected to a pull up through a 10 K $\Omega$ or less pull up resistor. The device behaves in QDR-I mode when the DLL is turned off. In this mode, the device operates at a frequency of up to 167 MHz with QDR-I timing. |
| TDO               | Output          | <b>TDO for JTAG.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| TCK               | Input           | <b>TCK Pin for JTAG.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| TDI               | Input           | <b>TDI Pin for JTAG.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| TMS               | Input           | <b>TMS Pin for JTAG.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| NC                | N/A             | <b>Not Connected to the Die.</b> Can be tied to any voltage level.                                                                                                                                                                                                                                                                                                                                                                                                |
| NC/36M            | N/A             | <b>Not Connected to the Die.</b> Can be tied to any voltage level.                                                                                                                                                                                                                                                                                                                                                                                                |
| NC/72M            | N/A             | <b>Not Connected to the Die.</b> Can be tied to any voltage level.                                                                                                                                                                                                                                                                                                                                                                                                |
| NC/144M           | N/A             | <b>Not Connected to the Die.</b> Can be tied to any voltage level.                                                                                                                                                                                                                                                                                                                                                                                                |
| NC/288M           | N/A             | <b>Not Connected to the Die.</b> Can be tied to any voltage level.                                                                                                                                                                                                                                                                                                                                                                                                |
| $V_{REF}$         | Input-Reference | <b>Reference Voltage Input.</b> Static input used to set the reference level for HSTL inputs, outputs, and AC measurement points.                                                                                                                                                                                                                                                                                                                                 |
| $V_{DD}$          | Power Supply    | <b>Power Supply Inputs to the Core of the Device.</b>                                                                                                                                                                                                                                                                                                                                                                                                             |
| $V_{SS}$          | Ground          | <b>Ground for the Device.</b>                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| $V_{DDQ}$         | Power Supply    | <b>Power Supply Inputs for the Outputs of the Device.</b>                                                                                                                                                                                                                                                                                                                                                                                                         |



## Functional Overview

The CY7C1161V18, CY7C1176V18, CY7C1163V18, and CY7C1165V18 are synchronous pipelined burst SRAMs equipped with both a read port and a write port. The read port is dedicated to read operations and the write port is dedicated to write operations. Data flows into the SRAM through the write port and out through the read port. These devices multiplex the address inputs in order to minimize the number of address pins required. By having separate read and write ports, the QDR-II+ completely eliminates the need to “turn-around” the data bus. It avoids any possible data contention, thereby, simplifying system design. Each access consists of four 8-bit data transfers in the case of CY7C1161V18, four 9-bit data transfers in the case of CY7C1176V18, four 18-bit data transfers in the case of CY7C1163V18, and four 36-bit data transfers in the case of CY7C1165V18 in two clock cycles.

Accesses for both ports are initiated on the positive input clock (K). All synchronous input and output timings are referenced to the rising edge of the Input clocks (K/K).

All synchronous data inputs ( $D_{[x:0]}$ ) pass through input registers controlled by the input clocks (K and  $\bar{K}$ ). All synchronous data outputs ( $Q_{[x:0]}$ ) pass through output registers controlled by the rising edge of the Input clocks (K and  $\bar{K}$ ) also.

All synchronous control ( $\overline{RPS}$ ,  $\overline{WPS}$ ,  $\overline{BWS}_{[x:0]}$ ) inputs pass through input registers controlled by the rising edge of the input clocks (K and  $\bar{K}$ ).

CY7C1163V18 is described in the following sections. The same basic descriptions apply to CY7C1161V18, CY7C1176V18, and CY7C1165V18.

### Read Operations

The CY7C1163V18 is organized internally as four arrays of 256K x 18. Accesses are completed in a burst of four sequential 18-bit data words. Read operations are initiated by asserting  $\overline{RPS}$  active at the rising edge of the positive input clock (K). The address presented to address inputs are stored in the Read address register. Following the next two K clock rises, the corresponding lowest order 18-bit word of data is driven onto the  $Q_{[17:0]}$  using K as the output timing reference. On the subsequent rising edge of K, the next 18-bit data word is driven onto the  $Q_{[17:0]}$ . This process continues until all four 18-bit data words have been driven out onto  $Q_{[17:0]}$ . The requested data is valid 0.45 ns from the rising edge of the Input clock K or  $\bar{K}$ . In order to maintain the internal logic, each read access must be allowed to complete. Each read access consists of four 18-bit data words and takes two clock cycles to complete. Therefore, read accesses to the device cannot be initiated on two consecutive K clock rises. The internal logic of the device ignores the second read request. Read accesses can be initiated on every other K clock rise. Doing so pipelines the data flow such that data is transferred out of the device on every rising edge of the input clocks K and  $\bar{K}$ .

When the read port is deselected, the CY7C1163V18 first completes the pending read transactions. Synchronous internal circuitry automatically tri-states the outputs following the next rising edge of the negative input clock ( $\bar{K}$ ). This allows for a seamless transition between devices without the insertion of wait states in a depth expanded memory.

### Write Operations

Write operations are initiated by asserting  $\overline{WPS}$  active at the rising edge of the positive input clock (K). On the following K clock rise, the data presented to  $D_{[17:0]}$  is latched and stored into the lower 18-bit write data register, provided  $\overline{BWS}_{[1:0]}$  are both asserted active. On the subsequent rising edge of the negative input clock ( $\bar{K}$ ), the information presented to  $D_{[17:0]}$  is also stored into the write data register, provided  $\overline{BWS}_{[1:0]}$  are both asserted active. This process continues for one more cycle until four 18-bit words (a total of 72 bits) of data are stored in the SRAM. The 72 bits of data are then written into the memory array at the specified location. Therefore, write accesses to the device cannot be initiated on two consecutive K clock rises. The internal logic of the device ignores the second write request. Write accesses are initiated on every other rising edge of the positive input clock (K). Doing so pipelines the data flow such that 18 bits of data can be transferred into the device on every rising edge of the input clocks (K and  $\bar{K}$ ).

When deselected, the write port ignores all inputs after the pending write operations are completed.

### Byte Write Operations

Byte write operations are supported by the CY7C1163V18. A write operation is initiated as described in the [Write Operations](#) section above. The bytes that are written are determined by  $\overline{BWS}_0$  and  $\overline{BWS}_1$ , which are sampled with each set of 18-bit data words. Asserting the appropriate byte write select input during the data portion of a write enables the data being presented to be latched and written into the device. Deasserting the byte write select input during the data portion of a write allows the data stored in the device for that byte to remain unaltered. This feature is used to simplify read, modify, and write operations to a byte write operation.

### Concurrent Transactions

The read and write ports on the CY7C1163V18 operate completely independent of one another. Because each port latches the address inputs on different clock edges, the user can read or write to any location, regardless of the transaction on the other port. If the ports access the same location when a read follows a write in successive clock cycles, the SRAM delivers the most recent information associated with the specified address location. This includes forwarding data from a write cycle initiated on the previous K clock rise.

Read accesses and write access are scheduled such that one transaction is initiated on any clock cycle. If both ports are selected on the same K clock rise, the arbitration depends on the previous state of the SRAM. If both ports are deselected, the read port takes priority. If a read is initiated on the previous cycle, the write port assumes priority (because read operations cannot be initiated on consecutive cycles). If a write was initiated on the previous cycle, the read port assumes priority (because write operations cannot be initiated on consecutive cycles). Therefore, asserting both port selects active from a deselected state results in alternating read or write operations initiated, with the first access being a read.



### Depth Expansion

The CY7C1163V18 has a port select input for each port. This enables easy depth expansion. Both port selects are only sampled on the rising edge of the positive input clock (K). Each port select input can deselect the specified port. Deselecting a port does not affect the other port. All pending transactions (read and write) are completed before the device is deselected.

### Programmable Impedance

An external resistor, RQ, must be connected between the ZQ pin on the SRAM and V<sub>SS</sub> to enable the SRAM to adjust its output driver impedance. The value of RQ must be 5X the value of the intended line impedance driven by the SRAM. The allowable range of RQ to guarantee impedance matching with a tolerance of  $\pm 15\%$  is between 175 $\Omega$  and 350 $\Omega$ , with V<sub>DDQ</sub> = 1.5V. The output impedance is adjusted every 1024 cycles upon power up to account for drifts in supply voltage and temperature.

### Echo Clocks

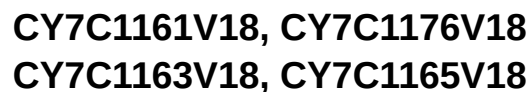
Echo clocks are provided on the QDR-II+ to simplify data capture on high speed systems. Two echo clocks are generated by the QDR-II+. CQ is referenced with respect to K and CQ is referenced with respect to K. These are free running clocks and are synchronized to the input clock of the QDR-II+. The timings for the echo clocks are shown in the AC timing table.

### Valid Data Indicator (QVLD)

QVLD is provided on the QDR-II+ to simplify data capture on high speed systems. The QVLD is generated by the QDR-II+ device along with data output. This signal is also edge-aligned with the echo clock and follows the timing of any data pin. This signal is asserted half a cycle before valid data arrives.

### DLL

These chips utilize a Delay Lock Loop (DLL) that is designed to function between 120 MHz and the specified maximum clock frequency. The DLL may be disabled by applying ground to the DOFF pin. When the DLL is turned off, the device behaves in QDR-I mode (with 1.0 cycle latency and a longer access time). For more information, refer to the application note, "[DLL Considerations in QDRII/DDRII/QDRII+/DDRII+](#)." The DLL can also be reset by slowing or stopping the input clocks K and K for a minimum of 30 ns. However, it is not necessary for the DLL to be reset in order to lock to the desired frequency. During power up when the DOFF is tied HIGH, the DLL is locked after 2048 cycles of stable clock.



## Write Cycle Descriptions

The write cycle descriptions of CY7C1161V18 and CY7C1163V18 follow.<sup>[3, 11]</sup>

| $\overline{BWS}_0$ /<br>$\overline{NWS}_0$ | $\overline{BWS}_1$ /<br>$\overline{NWS}_1$ | K   | $\overline{K}$ | Comments                                                                                                                                                                                                                                                                        |
|--------------------------------------------|--------------------------------------------|-----|----------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| L                                          | L                                          | L-H | –              | During the data portion of a write sequence:<br>CY7C1161V18 – both nibbles ( $D_{[7:0]}$ ) are written into the device.<br>CY7C1163V18 – both bytes ( $D_{[17:0]}$ ) are written into the device.                                                                               |
| L                                          | L                                          | –   | L-H            | During the data portion of a write sequence:<br>CY7C1161V18 – both nibbles ( $D_{[7:0]}$ ) are written into the device.<br>CY7C1163V18 – both bytes ( $D_{[17:0]}$ ) are written into the device.                                                                               |
| L                                          | H                                          | L-H | –              | During the data portion of a write sequence:<br>CY7C1161V18 – only the lower nibble ( $D_{[3:0]}$ ) is written into the device, $D_{[7:4]}$ remains unaltered.<br>CY7C1163V18 – only the lower byte ( $D_{[8:0]}$ ) is written into the device, $D_{[17:9]}$ remains unaltered. |
| L                                          | H                                          | –   | L-H            | During the data portion of a write sequence:<br>CY7C1161V18 – only the lower nibble ( $D_{[3:0]}$ ) is written into the device, $D_{[7:4]}$ remains unaltered.<br>CY7C1163V18 – only the lower byte ( $D_{[8:0]}$ ) is written into the device, $D_{[17:9]}$ remains unaltered. |
| H                                          | L                                          | L-H | –              | During the data portion of a write sequence:<br>CY7C1161V18 – only the upper nibble ( $D_{[7:4]}$ ) is written into the device, $D_{[3:0]}$ remains unaltered.<br>CY7C1163V18 – only the upper byte ( $D_{[17:9]}$ ) is written into the device, $D_{[8:0]}$ remains unaltered. |
| H                                          | L                                          | –   | L-H            | During the data portion of a write sequence:<br>CY7C1161V18 – only the upper nibble ( $D_{[7:4]}$ ) is written into the device, $D_{[3:0]}$ remains unaltered.<br>CY7C1163V18 – only the upper byte ( $D_{[17:9]}$ ) is written into the device, $D_{[8:0]}$ remains unaltered. |
| H                                          | H                                          | L-H | –              | No data is written into the device during this portion of a write operation.                                                                                                                                                                                                    |
| H                                          | H                                          | –   | L-H            | No data is written into the device during this portion of a write operation.                                                                                                                                                                                                    |

The write cycle operation of CY7C1176V18 follows.<sup>[3, 11]</sup>

| $\overline{BWS}_0$ | K   | K   | Comments                                                                                                 |
|--------------------|-----|-----|----------------------------------------------------------------------------------------------------------|
| L                  | L-H | –   | During the data portion of a write sequence, the single byte ( $D_{[8:0]}$ ) is written into the device. |
| L                  | –   | L-H | During the data portion of a write sequence, the single byte ( $D_{[8:0]}$ ) is written into the device. |
| H                  | L-H | –   | No data is written into the device during this portion of a write operation.                             |
| H                  | –   | L-H | No data is written into the device during this portion of a write operation.                             |

### Note

11. Is based upon a Write cycle was initiated per the Write Cycle Description Truth Table.  $\overline{NWS}_0$ ,  $\overline{NWS}_1$ ,  $\overline{BWS}_0$ ,  $\overline{BWS}_1$ ,  $\overline{BWS}_2$ , and  $\overline{BWS}_3$  can be altered on different portions of a Write cycle, as long as the setup and hold requirements are achieved.

The write cycle descriptions of CY7C1165V18 follows.<sup>[3, 11]</sup>

| $\overline{\text{BWS}}_0$ | $\overline{\text{BWS}}_1$ | $\overline{\text{BWS}}_2$ | $\overline{\text{BWS}}_3$ | K   | $\overline{\text{K}}$ | Comments                                                                                                                                                                        |
|---------------------------|---------------------------|---------------------------|---------------------------|-----|-----------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| L                         | L                         | L                         | L                         | L-H | –                     | During the data portion of a write sequence, all four bytes ( $\text{D}_{[35:0]}$ ) are written into the device.                                                                |
| L                         | L                         | L                         | L                         | –   | L-H                   | During the data portion of a write sequence, all four bytes ( $\text{D}_{[35:0]}$ ) are written into the device.                                                                |
| L                         | H                         | H                         | H                         | L-H | –                     | During the data portion of a write sequence, only the lower byte ( $\text{D}_{[8:0]}$ ) is written into the device. $\text{D}_{[35:9]}$ remains unaltered.                      |
| L                         | H                         | H                         | H                         | –   | L-H                   | During the data portion of a write sequence, only the lower byte ( $\text{D}_{[8:0]}$ ) is written into the device. $\text{D}_{[35:9]}$ remains unaltered.                      |
| H                         | L                         | H                         | H                         | L-H | –                     | During the data portion of a write sequence, only the byte ( $\text{D}_{[17:9]}$ ) is written into the device. $\text{D}_{[8:0]}$ and $\text{D}_{[35:18]}$ remains unaltered.   |
| H                         | L                         | H                         | H                         | –   | L-H                   | During the data portion of a write sequence, only the byte ( $\text{D}_{[17:9]}$ ) is written into the device. $\text{D}_{[8:0]}$ and $\text{D}_{[35:18]}$ remains unaltered.   |
| H                         | H                         | L                         | H                         | L-H | –                     | During the data portion of a write sequence, only the byte ( $\text{D}_{[26:18]}$ ) is written into the device. $\text{D}_{[17:0]}$ and $\text{D}_{[35:27]}$ remains unaltered. |
| H                         | H                         | L                         | H                         | –   | L-H                   | During the data portion of a write sequence, only the byte ( $\text{D}_{[26:18]}$ ) is written into the device. $\text{D}_{[17:0]}$ and $\text{D}_{[35:27]}$ remains unaltered. |
| H                         | H                         | H                         | L                         | L-H | –                     | During the data portion of a write sequence, only the byte ( $\text{D}_{[35:27]}$ ) is written into the device. $\text{D}_{[26:0]}$ remains unaltered.                          |
| H                         | H                         | H                         | L                         | –   | L-H                   | During the data portion of a write sequence, only the byte ( $\text{D}_{[35:27]}$ ) is written into the device. $\text{D}_{[26:0]}$ remains unaltered.                          |
| H                         | H                         | H                         | H                         | L-H | –                     | No data is written into the device during this portion of a write operation.                                                                                                    |
| H                         | H                         | H                         | H                         | –   | L-H                   | No data is written into the device during this portion of a write operation.                                                                                                    |

## IEEE 1149.1 Serial Boundary Scan (JTAG)

These SRAMs incorporate a serial boundary scan test access port (TAP) in the FBGA package. This part is fully compliant with IEEE Standard 1149.1-2001. The TAP operates using JEDEC standard 1.8V IO logic levels.

### Disabling the JTAG Feature

It is possible to operate the SRAM without using the JTAG feature. To disable the TAP controller, TCK must be tied LOW ( $V_{SS}$ ) to prevent clocking of the device. TDI and TMS are internally pulled up and may be unconnected. They may alternatively be connected to  $V_{DD}$  through a pull up resistor. TDO must be left unconnected. Upon power up, the device comes up in a reset state which does not interfere with the operation of the device.

### Test Access Port—Test Clock

The test clock is used only with the TAP controller. All inputs are captured on the rising edge of TCK. All outputs are driven from the falling edge of TCK.

### Test Mode Select

The TMS input is used to give commands to the TAP controller and is sampled on the rising edge of TCK. It is allowable to leave this pin unconnected if the TAP is not used. The pin is pulled up internally, resulting in a logic HIGH level.

### Test Data In (TDI)

The TDI pin is used to serially input information into the registers and can be connected to the input of any of the registers. The register between TDI and TDO is chosen by the instruction that is loaded into the TAP instruction register. For information on loading the instruction register, see [“TAP Controller State Diagram”](#) on page 15. TDI is internally pulled up and can be unconnected if the TAP is unused in an application. TDI is connected to the most significant bit (MSb) on any register.

### Test Data Out (TDO)

The TDO output pin is used to serially clock data out from the registers. The output is active depending upon the current state of the TAP state machine, see [“Instruction Codes”](#) on page 18. The output changes on the falling edge of TCK. TDO is connected to the least significant bit (LSb) of any register.

### Performing a TAP Reset

A Reset is performed by forcing TMS HIGH ( $V_{DD}$ ) for five rising edges of TCK. This RESET does not affect the operation of the SRAM and may be performed while the SRAM is operating. At power up, the TAP is reset internally to ensure that TDO comes up in a high Z state.

### TAP Registers

Registers are connected between the TDI and TDO pins and enables data to be scanned into and out of the SRAM test circuitry. Only one register is selected at a time through the instruction registers. Data is serially loaded into the TDI pin on the rising edge of TCK. Data outputs on the TDO pin on the falling edge of TCK.

#### Instruction Register

Three-bit instructions are serially loaded into the instruction register. This register is loaded when it is placed between the TDI and TDO pins as shown in [“TAP Controller Block Diagram”](#) on page 16. Upon power up, the instruction register is loaded with the IDCODE instruction. It is also loaded with the IDCODE instruction if the controller is placed in a reset state as described in the previous section.

When the TAP controller is in the Capture IR state, the two least significant bits are loaded with a binary “01” pattern to allow fault isolation of the board level serial test path.

#### Bypass Register

To save time when serially shifting data through registers, it is sometimes advantageous to skip certain chips. The bypass register is a single-bit register that can be placed between TDI and TDO pins. This enables data to be shifted through the SRAM with minimal delay. The bypass register is set LOW ( $V_{SS}$ ) when the BYPASS instruction is executed.

#### Boundary Scan Register

The boundary scan register is connected to all of the input and output pins on the SRAM. Several no connect (NC) pins are also included in the scan register to reserve pins for higher density devices.

The boundary scan register is loaded with the contents of the RAM Input and Output ring when the TAP controller is in the Capture-DR state and is then placed between the TDI and TDO pins when the controller is moved to the Shift-DR state. The EXTEST, SAMPLE/PRELOAD and SAMPLE Z instructions can be used to capture the contents of the Input and Output ring.

The [“Boundary Scan Order”](#) on page 19 show the order in which the bits are connected. Each bit corresponds to one of the bumps on the SRAM package. The MSb of the register is connected to TDI and the LSb is connected to TDO.

#### Identification (ID) Register

The ID register is loaded with a vendor-specific 32-bit code during the Capture-DR state when the IDCODE command is loaded in the instruction register. The IDCODE is hardwired into the SRAM and can be shifted out when the TAP controller is in the Shift-DR state. The ID register has a vendor code and other information described in the [“Identification Register Definitions”](#) on page 18.

### TAP Instruction Set

Eight different instructions are possible with the three-bit instruction register. All combinations are listed in the [“Instruction Codes”](#) on page 18. Three of these instructions are listed as RESERVED and must not be used. The other five instructions are described below.

Instructions are loaded into the TAP controller during the Shift-IR state when the instruction register is placed between TDI and TDO. During this state, instructions are shifted through the instruction register through the TDI and TDO pins. To execute the instruction once it is shifted in, the TAP controller needs to be moved into the Update-IR state.

#### **IDCODE**

The IDCODE instruction causes a vendor-specific 32-bit code to be loaded into the instruction register. It also places the instruction register between the TDI and TDO pins and enables the IDCODE to be shifted out of the device when the TAP controller enters the Shift-DR state. The IDCODE instruction is loaded into the instruction register upon power up or whenever the TAP controller is given a test logic reset state.

#### **SAMPLE Z**

The SAMPLE Z instruction causes the boundary scan register to be connected between the TDI and TDO pins when the TAP controller is in a Shift-DR state. The SAMPLE Z command puts the output bus into a High Z state until the next command is given during the Update IR state.

#### **SAMPLE/PRELOAD**

SAMPLE/PRELOAD is a 1149.1 mandatory instruction. When the SAMPLE/PRELOAD instructions are loaded into the instruction register and the TAP controller is in the Capture-DR state, a snapshot of data on the inputs and output pins is captured in the boundary scan register.

The user must be aware that the TAP controller clock only operates at a frequency up to 20 MHz, while the SRAM clock operates more than an order of magnitude faster. Because there is a large difference in the clock frequencies, it is possible that during the Capture-DR state, an input or output undergoes a transition. The TAP then tries to capture a signal while in transition (metastable state). This does not harm the device but there is no guarantee as to the value that is captured. Repeatable results are not possible.

To guarantee that the boundary scan register captures the correct value of a signal, the SRAM signal is stabilized long enough to meet the TAP controller's capture setup plus hold times ( $t_{CS}$  and  $t_{CH}$ ). The SRAM clock input is not captured correctly if there is no way in a design to stop (or slow) the clock during a SAMPLE/PRELOAD instruction. If this is an issue, it is still possible to capture all other signals and simply ignore the value of the CK and CK captured in the boundary scan register.

Once the data is captured, it is possible to shift out the data by putting the TAP into the Shift-DR state. This places the boundary scan register between the TDI and TDO pins.

PRELOAD enables an initial data pattern to be placed at the latched parallel outputs of the boundary scan register cells before the selection of another boundary scan test operation.

The shifting of data for the SAMPLE and PRELOAD phases can occur concurrently when required—that is, while data captured is shifted out, the preloaded data is shifted in.

#### **BYPASS**

When the BYPASS instruction is loaded in the instruction register and the TAP is placed in a Shift-DR state, the bypass register is placed between the TDI and TDO pins. The advantage of the BYPASS instruction is that it shortens the boundary scan path when multiple devices are connected together on a board.

#### **EXTEST**

The EXTEST instruction enables the preloaded data to be driven out through the system output pins. This instruction also selects the boundary scan register to be connected for serial access between the TDI and TDO in the shift-DR controller state.

#### **EXTEST OUTPUT BUS TRI-STATE**

IEEE Standard 1149.1 mandates that the TAP controller puts the output bus into a tri-state mode.

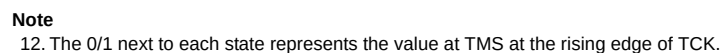
The boundary scan register has a special bit located at bit 47. When this scan cell, called the "extest output bus tri-state", is latched into the preload register during the Update-DR state in the TAP controller, it directly controls the state of the output (Q-bus) pins, when the EXTEST is entered as the current instruction. When HIGH, it enables the output buffers to drive the output bus. When LOW, this bit places the output bus into a High Z condition.

This bit is set by entering the SAMPLE/PRELOAD or EXTEST command, and then shifting the desired bit into that cell, during the Shift-DR state. During Update-DR, the value loaded into that shift register cell latches into the preload register. When the EXTEST instruction is entered, this bit directly controls the output Q-bus pins. Note that this bit is preset HIGH to enable the output when the device is powered up, and also when the TAP controller is in the Test Logic Reset state.

#### **Reserved**

These instructions are not implemented but are reserved for future use. Do not use these instructions.

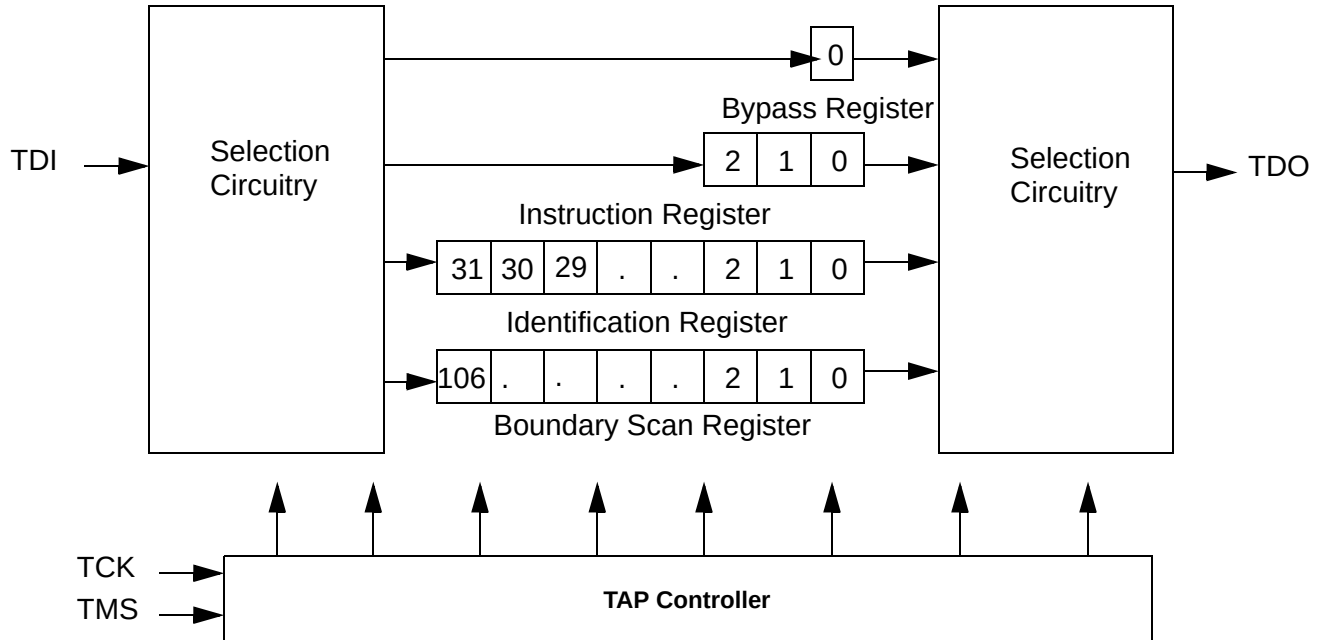
**Figure 2. Tap Controller State Diagram<sup>[12]</sup>**





## TAP Controller Block Diagram

Figure 3. Tap Controller Block Diagram



## TAP Electrical Characteristics

The Tap Electrical Characteristics table over the operating range follows.<sup>[13, 14, 15]</sup>

| Parameter        | Description                   | Test Conditions                        | Min                  | Max                   | Unit |
|------------------|-------------------------------|----------------------------------------|----------------------|-----------------------|------|
| V <sub>OH1</sub> | Output HIGH Voltage           | I <sub>OH</sub> = -2.0 mA              | 1.4                  |                       | V    |
| V <sub>OH2</sub> | Output HIGH Voltage           | I <sub>OH</sub> = -100 µA              | 1.6                  |                       | V    |
| V <sub>OL1</sub> | Output LOW Voltage            | I <sub>OL</sub> = 2.0 mA               |                      | 0.4                   | V    |
| V <sub>OL2</sub> | Output LOW Voltage            | I <sub>OL</sub> = 100 µA               |                      | 0.2                   | V    |
| V <sub>IH</sub>  | Input HIGH Voltage            |                                        | 0.65 V <sub>DD</sub> | V <sub>DD</sub> + 0.3 | V    |
| V <sub>IL</sub>  | Input LOW Voltage             |                                        | -0.3                 | 0.35 V <sub>DD</sub>  | V    |
| I <sub>X</sub>   | Input and Output Load Current | GND ≤ V <sub>I</sub> ≤ V <sub>DD</sub> | -5                   | 5                     | µA   |

### Notes

13. These characteristic pertain to the TAP inputs (TMS, TCK, TDI and TDO). Parallel load levels are specified in the Electrical Characteristics table.  
 14. Overshoot: V<sub>IH</sub>(AC) ≤ V<sub>DDQ</sub> + 0.35V (pulse width less than t<sub>CYC</sub>/2), Undershoot: V<sub>IL</sub>(AC) ≥ -0.3V (pulse width less than t<sub>CYC</sub>/2)  
 15. All voltage referenced to ground.

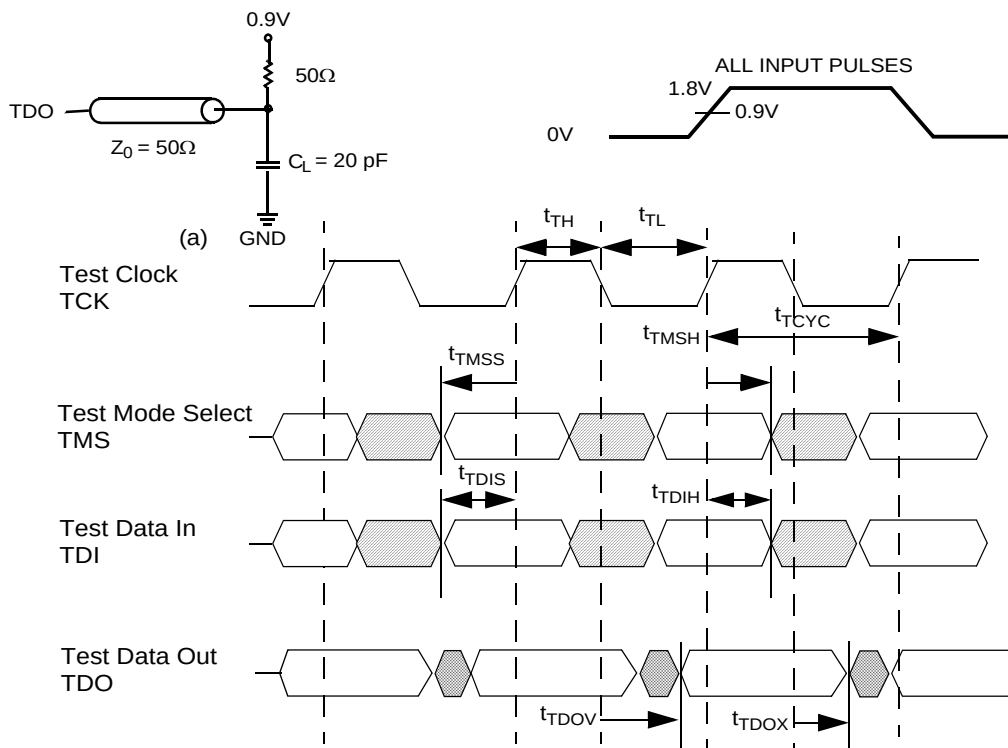
## TAP AC Switching Characteristics

The Tap AC Switching Characteristics over the operating range follows.<sup>[16, 17]</sup>

| Parameter           | Description                   | Min | Max | Unit |
|---------------------|-------------------------------|-----|-----|------|
| $t_{TCYC}$          | TCK Clock Cycle Time          | 50  |     | ns   |
| $t_{TF}$            | TCK Clock Frequency           |     | 20  | MHz  |
| $t_{TH}$            | TCK Clock HIGH                | 20  |     | ns   |
| $t_{TL}$            | TCK Clock LOW                 | 20  |     | ns   |
| <b>Setup Times</b>  |                               |     |     |      |
| $t_{TMSS}$          | TMS Setup to TCK Clock Rise   | 5   |     | ns   |
| $t_{TDIS}$          | TDI Setup to TCK Clock Rise   | 5   |     | ns   |
| $t_{CS}$            | Capture Setup to TCK Rise     | 5   |     | ns   |
| <b>Hold Times</b>   |                               |     |     |      |
| $t_{TMSH}$          | TMS Hold after TCK Clock Rise | 5   |     | ns   |
| $t_{TDIH}$          | TDI Hold after Clock Rise     | 5   |     | ns   |
| $t_{CH}$            | Capture Hold after Clock Rise | 5   |     | ns   |
| <b>Output Times</b> |                               |     |     |      |
| $t_{TDOV}$          | TCK Clock LOW to TDO Valid    |     | 10  | ns   |
| $t_{TDOX}$          | TCK Clock LOW to TDO Invalid  | 0   |     | ns   |

## TAP Timing and Test Conditions

The Tap Timing and Test Conditions for the CY7C1161V18, CY7C1176V18, CY7C1163V18, and CY7C1165V18 follows.<sup>[17]</sup>



### Notes

16.  $t_{CS}$  and  $t_{CH}$  refer to the setup and hold time requirements of latching data from the boundary scan register.

17. Test conditions are specified using the load in TAP AC test conditions.  $t_R/t_F = 1$  ns.

## Identification Register Definitions

| Instruction Field         | Value             |                   |                   |                   | Description                                   |
|---------------------------|-------------------|-------------------|-------------------|-------------------|-----------------------------------------------|
|                           | CY7C1161V18       | CY7C1176V18       | CY7C1163V18       | CY7C1165V18       |                                               |
| Revision Number (31:29)   | 000               | 000               | 000               | 000               | Version number.                               |
| Cypress Device ID (28:12) | 11010010001000101 | 11010010001001101 | 11010010001010101 | 11010010001100101 | Defines the type of SRAM.                     |
| Cypress JEDEC ID (11:1)   | 00000110100       | 00000110100       | 00000110100       | 00000110100       | Enables unique identification of SRAM vendor. |
| ID Register Presence (0)  | 1                 | 1                 | 1                 | 1                 | Indicates the presence of an ID register.     |

## Scan Register Sizes

| Register Name | Bit Size |
|---------------|----------|
| Instruction   | 3        |
| Bypass        | 1        |
| ID            | 32       |
| Boundary Scan | 107      |

## Instruction Codes

| Instruction    | Code | Description                                                                                                                                            |
|----------------|------|--------------------------------------------------------------------------------------------------------------------------------------------------------|
| EXTEST         | 000  | Captures the input and output ring contents.                                                                                                           |
| IDCODE         | 001  | Loads the ID register with the vendor ID code and places the register between TDI and TDO. This operation does not affect SRAM operation.              |
| SAMPLE Z       | 010  | Captures the input and output contents. Places the boundary scan register between TDI and TDO. This forces all SRAM output drivers to a High Z state.  |
| RESERVED       | 011  | Do Not Use: This instruction is reserved for future use.                                                                                               |
| SAMPLE/PRELOAD | 100  | Captures the input and output ring contents. Places the boundary scan register between TDI and TDO. This operation does not affect the SRAM operation. |
| RESERVED       | 101  | Do Not Use: This instruction is reserved for future use.                                                                                               |
| RESERVED       | 110  | Do Not Use: This instruction is reserved for future use.                                                                                               |
| BYPASS         | 111  | Places the bypass register between TDI and TDO. This operation does not affect SRAM operation.                                                         |

**Boundary Scan Order**

| Bit # | Bump ID | Bit # | Bump ID  | Bit # | Bump ID | Bit # | Bump ID |
|-------|---------|-------|----------|-------|---------|-------|---------|
| 0     | 6R      | 27    | 11H      | 54    | 7B      | 81    | 3G      |
| 1     | 6P      | 28    | 10G      | 55    | 6B      | 82    | 2G      |
| 2     | 6N      | 29    | 9G       | 56    | 6A      | 83    | 1J      |
| 3     | 7P      | 30    | 11F      | 57    | 5B      | 84    | 2J      |
| 4     | 7N      | 31    | 11G      | 58    | 5A      | 85    | 3K      |
| 5     | 7R      | 32    | 9F       | 59    | 4A      | 86    | 3J      |
| 6     | 8R      | 33    | 10F      | 60    | 5C      | 87    | 2K      |
| 7     | 8P      | 34    | 11E      | 61    | 4B      | 88    | 1K      |
| 8     | 9R      | 35    | 10E      | 62    | 3A      | 89    | 2L      |
| 9     | 11P     | 36    | 10D      | 63    | 1H      | 90    | 3L      |
| 10    | 10P     | 37    | 9E       | 64    | 1A      | 91    | 1M      |
| 11    | 10N     | 38    | 10C      | 65    | 2B      | 92    | 1L      |
| 12    | 9P      | 39    | 11D      | 66    | 3B      | 93    | 3N      |
| 13    | 10M     | 40    | 9C       | 67    | 1C      | 94    | 3M      |
| 14    | 11N     | 41    | 9D       | 68    | 1B      | 95    | 1N      |
| 15    | 9M      | 42    | 11B      | 69    | 3D      | 96    | 2M      |
| 16    | 9N      | 43    | 11C      | 70    | 3C      | 97    | 3P      |
| 17    | 11L     | 44    | 9B       | 71    | 1D      | 98    | 2N      |
| 18    | 11M     | 45    | 10B      | 72    | 2C      | 99    | 2P      |
| 19    | 9L      | 46    | 11A      | 73    | 3E      | 100   | 1P      |
| 20    | 10L     | 47    | Internal | 74    | 2D      | 101   | 3R      |
| 21    | 11K     | 48    | 9A       | 75    | 2E      | 102   | 4R      |
| 22    | 10K     | 49    | 8B       | 76    | 1E      | 103   | 4P      |
| 23    | 9J      | 50    | 7C       | 77    | 2F      | 104   | 5P      |
| 24    | 9K      | 51    | 6C       | 78    | 3F      | 105   | 5N      |
| 25    | 10J     | 52    | 8A       | 79    | 1G      | 106   | 5R      |
| 26    | 11J     | 53    | 7A       | 80    | 1F      |       |         |

## Power Up Sequence in QDR-II+ SRA

During power up, when the  $\overline{\text{DOFF}}$  is tied HIGH, the DLL gets locked after 2048 cycles of stable clock. QDR-II+ SRAMs must be powered up and initialized in a predefined manner to prevent undefined operations.

## Power Up Sequence

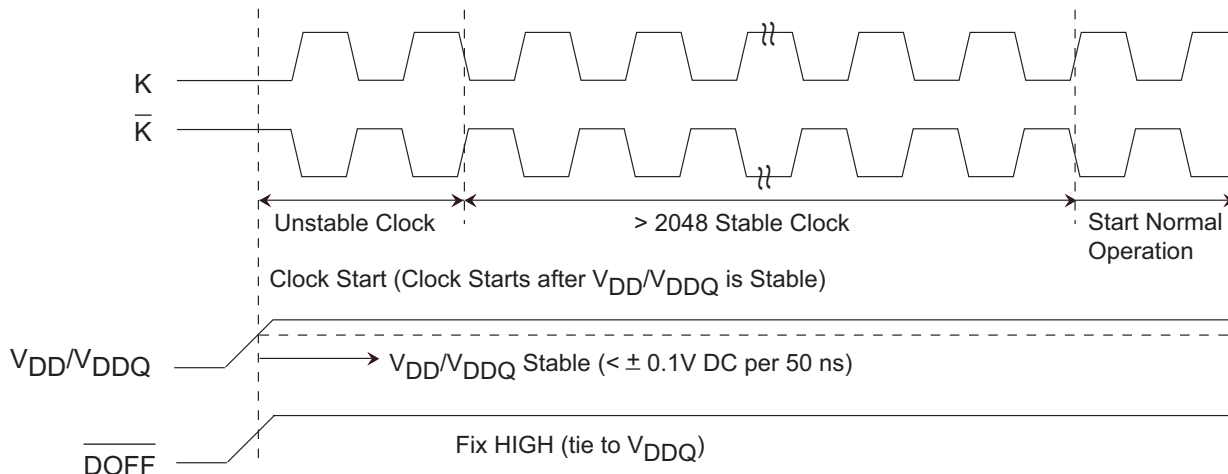
- Apply power with  $\overline{\text{DOFF}}$  tied HIGH (All other inputs can be HIGH or LOW)
  - Apply  $V_{\text{DD}}$  before  $V_{\text{DDQ}}$
  - Apply  $V_{\text{DDQ}}$  before  $V_{\text{REF}}$  or at the same time as  $V_{\text{REF}}$
- Provide stable power and clock (K,  $\overline{\text{K}}$ ) for 2048 cycles to lock the DLL

## Power Up Waveforms

## DLL Constraints

- DLL uses K clock as its synchronizing input. The input must have low phase jitter, which is specified as  $t_{\text{KC Var}}$
- The DLL functions at frequencies down to 120 MHz
- If the input clock is unstable and the DLL is enabled, then the DLL locks onto an incorrect frequency, causing unstable SRAM behavior. To avoid this, provide 2048 cycles stable clock to relock to the desired clock frequency

Figure 4. Power Up Waveforms



## Maximum Ratings

Exceeding maximum ratings may impair the useful life of the device. User guidelines are not tested.

Storage Temperature ..... -65°C to + 150°C  
 Ambient Temperature with Power Applied. -55°C to + 125°C  
 Supply Voltage on V<sub>DD</sub> Relative to GND ..... -0.5V to + 2.9V  
 Supply Voltage on V<sub>DDQ</sub> Relative to GND ..... -0.5V to + V<sub>DD</sub>  
 DC Applied to Outputs in High Z ..... -0.5V to V<sub>DDQ</sub> + 0.3V  
 DC Input Voltage<sup>[14]</sup> ..... -0.5V to V<sub>DD</sub> + 0.3V

Current into Outputs (LOW)..... 20 mA  
 Static Discharge Voltage (MIL-STD-883, M. 3015).. > 2001V  
 Latch up Current..... > 200 mA

## Operating Range

| Range      | Ambient Temperature (T <sub>A</sub> ) | V <sub>DD</sub> <sup>[18]</sup> | V <sub>DDQ</sub> <sup>[18]</sup> |
|------------|---------------------------------------|---------------------------------|----------------------------------|
| Commercial | 0°C to +70°C                          | 1.8 ± 0.1V                      | 1.4V to V <sub>DD</sub>          |
| Industrial | -40°C to +85°C                        |                                 |                                  |

## Electrical Characteristics

The DC Electrical Characteristics over the operating range follows.<sup>[15]</sup>

| Parameter                       | Description                             | Test Conditions                                                                                                                                                                           | Min                        | Typ  | Max                        | Unit |
|---------------------------------|-----------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------|------|----------------------------|------|
| V <sub>DD</sub>                 | Power Supply Voltage                    |                                                                                                                                                                                           | 1.7                        | 1.8  | 1.9                        | V    |
| V <sub>DDQ</sub>                | IO Supply Voltage                       |                                                                                                                                                                                           | 1.4                        | 1.5  | V <sub>DD</sub>            | V    |
| V <sub>OH</sub>                 | Output HIGH Voltage                     | Note 19                                                                                                                                                                                   | V <sub>DDQ</sub> /2 - 0.12 |      | V <sub>DDQ</sub> /2 + 0.12 | V    |
| V <sub>OL</sub>                 | Output LOW Voltage                      | Note 20                                                                                                                                                                                   | V <sub>DDQ</sub> /2 - 0.12 |      | V <sub>DDQ</sub> /2 + 0.12 | V    |
| V <sub>OH(LOW)</sub>            | Output HIGH Voltage                     | I <sub>OH</sub> = -0.1 mA, Nominal Impedance                                                                                                                                              | V <sub>DDQ</sub> - 0.2     |      | V <sub>DDQ</sub>           | V    |
| V <sub>OL(LOW)</sub>            | Output LOW Voltage                      | I <sub>OL</sub> = 0.1 mA, Nominal Impedance                                                                                                                                               | V <sub>SS</sub>            |      | 0.2                        | V    |
| V <sub>IH</sub>                 | Input HIGH Voltage                      |                                                                                                                                                                                           | V <sub>REF</sub> + 0.1     |      | V <sub>DDQ</sub> + 0.15    | V    |
| V <sub>IL</sub>                 | Input LOW Voltage                       |                                                                                                                                                                                           | -0.15                      |      | V <sub>REF</sub> - 0.1     | V    |
| I <sub>X</sub>                  | Input Leakage Current                   | GND ≤ V <sub>I</sub> ≤ V <sub>DDQ</sub>                                                                                                                                                   | -2                         |      | 2                          | μA   |
| I <sub>OZ</sub>                 | Output Leakage Current                  | GND ≤ V <sub>I</sub> ≤ V <sub>DDQ</sub> , Output Disabled                                                                                                                                 | -2                         |      | 2                          | μA   |
| V <sub>REF</sub>                | Input Reference Voltage <sup>[21]</sup> | Typical Value = 0.75V                                                                                                                                                                     | 0.68                       | 0.75 | 0.95                       | V    |
| I <sub>DD</sub> <sup>[22]</sup> | V <sub>DD</sub> Operating Supply        | V <sub>DD</sub> = Max, I <sub>OUT</sub> = 0 mA,<br>f = f <sub>max</sub> = 1/t <sub>CYC</sub>                                                                                              | 300 MHz                    |      | 850                        | mA   |
|                                 |                                         |                                                                                                                                                                                           | 333 MHz                    |      | 920                        | mA   |
|                                 |                                         |                                                                                                                                                                                           | 375 MHz                    |      | 1020                       | mA   |
|                                 |                                         |                                                                                                                                                                                           | 400 MHz                    |      | 1080                       | mA   |
| I <sub>SB1</sub>                | Automatic Power Down Current            | Max V <sub>DD</sub> ,<br>Both Ports Deselected,<br>V <sub>IN</sub> ≥ V <sub>IH</sub> or V <sub>IN</sub> ≤ V <sub>IL</sub><br>f = f <sub>max</sub> = 1/t <sub>CYC</sub> ,<br>Inputs Static | 300 MHz                    |      | 250                        | mA   |
|                                 |                                         |                                                                                                                                                                                           | 333 MHz                    |      | 260                        | mA   |
|                                 |                                         |                                                                                                                                                                                           | 375 MHz                    |      | 290                        | mA   |
|                                 |                                         |                                                                                                                                                                                           | 400 MHz                    |      | 300                        | mA   |

## AC Electrical Characteristics

Over the operating range follows.<sup>[21]</sup>

| Parameter       | Description        | Test Conditions | Min                    | Typ | Max                     | Unit |
|-----------------|--------------------|-----------------|------------------------|-----|-------------------------|------|
| V <sub>IH</sub> | Input HIGH Voltage |                 | V <sub>REF</sub> + 0.2 | -   | V <sub>DDQ</sub> + 0.24 | V    |
| V <sub>IL</sub> | Input LOW Voltage  |                 | -0.24                  | -   | V <sub>REF</sub> - 0.2  | V    |

### Notes

18. Power up: Is based upon a linear ramp from 0V to V<sub>DD(min)</sub> within 200 ms. During this time V<sub>IH</sub> < V<sub>DD</sub> and V<sub>DDQ</sub> ≤ V<sub>DD</sub>.  
 19. Output are impedance controlled. I<sub>OH</sub> = -(V<sub>DDQ</sub>/2)/(RQ/5) for values of 175Ω ≤ RQ ≤ 350Ω.  
 20. Output are impedance controlled. I<sub>OL</sub> = (V<sub>DDQ</sub>/2)/(RQ/5) for values of 175Ω ≤ RQ ≤ 350Ω.  
 21. V<sub>REF</sub> (min) = 0.68V or 0.46V<sub>DDQ</sub>, whichever is larger, V<sub>REF</sub> (max) = 0.95V or 0.54V<sub>DDQ</sub>, whichever is smaller.  
 22. The operation current is calculated with 50% read cycle and 50% write cycle.

## Capacitance

Tested initially and after any design or process change that may affect these parameters.

| Parameter | Description             | Test Conditions                                                                                      | Max | Unit |
|-----------|-------------------------|------------------------------------------------------------------------------------------------------|-----|------|
| $C_{IN}$  | Input Capacitance       | $T_A = 25^\circ\text{C}$ , $f = 1\text{ MHz}$ ,<br>$V_{DD} = 1.8\text{V}$<br>$V_{DDQ} = 1.5\text{V}$ | 5   | pF   |
| $C_{CLK}$ | Clock Input Capacitance |                                                                                                      | 6   | pF   |
| $C_O$     | Output Capacitance      |                                                                                                      | 7   | pF   |

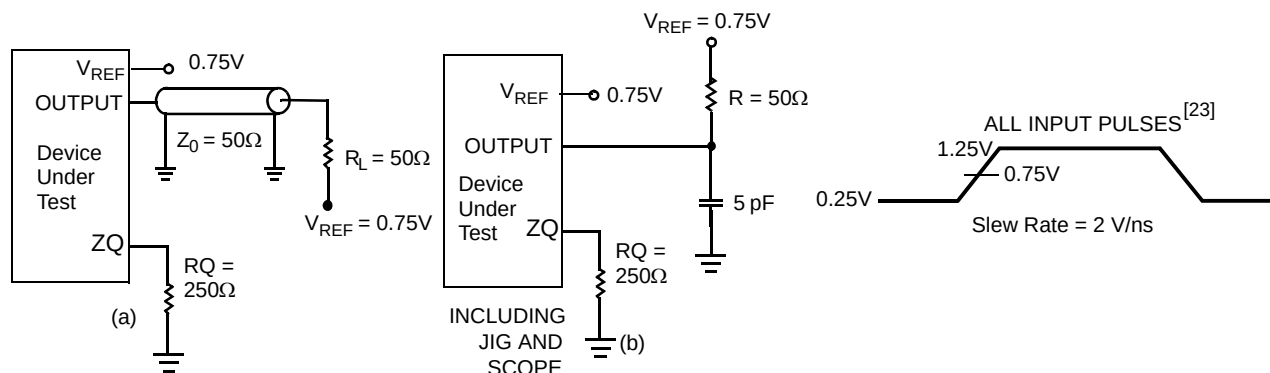
## Thermal Resistance

Tested initially and after any design or process change that may affect these parameters.

| Parameter     | Description                              | Test Conditions                                                                                                             | 165 FBGA Package | Unit               |
|---------------|------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------|------------------|--------------------|
| $\Theta_{JA}$ | Thermal Resistance (junction to ambient) | Test conditions follow standard test methods and procedures for measuring thermal impedance, in accordance with EIA/JESD51. | 17.2             | $^\circ\text{C/W}$ |
| $\Theta_{JC}$ | Thermal Resistance (junction to case)    |                                                                                                                             | 4.15             | $^\circ\text{C/W}$ |

## AC Test Loads and Waveforms

Figure 5. AC Test Loads and Waveforms



### Notes

23. Unless otherwise noted, test conditions are based upon signal transition time of  $2\text{V/ns}$ , timing reference levels of  $0.75\text{V}$ ,  $V_{ref} = 0.75\text{V}$ ,  $R_Q = 250\Omega$ ,  $V_{DDQ} = 1.5\text{V}$ , input pulse levels of  $0.25\text{V}$  to  $1.25\text{V}$ , and output loading of the specified  $I_{OL}/I_{OH}$  and load capacitance shown in (a) of AC Test Loads.



## Switching Characteristics

Over the operating range<sup>[23, 24]</sup>

| Cypress Parameter                      | Consortium Parameter                   | Description                                                                                              | 400 MHz |      | 375 MHz |      | 333 MHz |      | 300 MHz |      | Unit             |
|----------------------------------------|----------------------------------------|----------------------------------------------------------------------------------------------------------|---------|------|---------|------|---------|------|---------|------|------------------|
|                                        |                                        |                                                                                                          | Min     | Max  | Min     | Max  | Min     | Max  | Min     | Max  |                  |
| t <sub>POWER</sub>                     |                                        | V <sub>DD</sub> (Typical) to the First Access <sup>[25]</sup>                                            | 1       | –    | 1       | –    | 1       | –    | 1       | –    | ms               |
| t <sub>CYC</sub>                       | t <sub>KHKH</sub>                      | K Clock Cycle Time                                                                                       | 2.50    | 8.40 | 2.66    | 8.40 | 3.0     | 8.40 | 3.3     | 8.40 | ns               |
| t <sub>KH</sub>                        | t <sub>KHKL</sub>                      | Input Clock (K/ $\bar{K}$ ) HIGH                                                                         | 0.4     | –    | 0.4     | –    | 0.4     | –    | 0.4     | –    | t <sub>CYC</sub> |
| t <sub>KL</sub>                        | t <sub>KLKH</sub>                      | Input Clock (K/ $\bar{K}$ ) LOW                                                                          | 0.4     | –    | 0.4     | –    | 0.4     | –    | 0.4     | –    | t <sub>CYC</sub> |
| t <sub>KH<math>\bar{K}</math>H</sub>   | t <sub>KH<math>\bar{K}</math>H</sub>   | K Clock Rise to $\bar{K}$ Clock Rise (rising edge to rising edge)                                        | 1.06    | –    | 1.13    | –    | 1.28    | –    | 1.40    | –    | ns               |
| <b>Setup Times</b>                     |                                        |                                                                                                          |         |      |         |      |         |      |         |      |                  |
| t <sub>SA</sub>                        | t <sub>AVKH</sub>                      | Address Setup to K Clock Rise                                                                            | 0.4     | –    | 0.4     | –    | 0.4     | –    | 0.4     | –    | ns               |
| t <sub>SC</sub>                        | t <sub>IVKH</sub>                      | Control Setup to K Clock Rise ( $\overline{RPS}$ , $\overline{WPS}$ )                                    | 0.4     | –    | 0.4     | –    | 0.4     | –    | 0.4     | –    | ns               |
| t <sub>SCDDR</sub>                     | t <sub>IVKH</sub>                      | Double Data Rate Control Setup to Clock (K, $\bar{K}$ ) Rise ( $BWS_0$ , $BWS_1$ , $BWS_2$ , $BWS_3$ )   | 0.28    | –    | 0.28    | –    | 0.28    | –    | 0.28    | –    | ns               |
| t <sub>SD</sub>                        | t <sub>DVKH</sub>                      | D <sub>[X:0]</sub> Setup to Clock (K/ $\bar{K}$ ) Rise                                                   | 0.28    | –    | 0.28    | –    | 0.28    | –    | 0.28    | –    | ns               |
| <b>Hold Times</b>                      |                                        |                                                                                                          |         |      |         |      |         |      |         |      |                  |
| t <sub>HA</sub>                        | t <sub>KHAX</sub>                      | Address Hold after K Clock Rise                                                                          | 0.4     | –    | 0.4     | –    | 0.4     | –    | 0.4     | –    | ns               |
| t <sub>HC</sub>                        | t <sub>KHIX</sub>                      | Control Hold after K Clock Rise ( $\overline{RPS}$ , $\overline{WPS}$ )                                  | 0.4     | –    | 0.4     | –    | 0.4     | –    | 0.4     | –    | ns               |
| t <sub>HCDDR</sub>                     | t <sub>KHIX</sub>                      | Double Data Rate Control Hold after Clock (K/ $\bar{K}$ ) Rise ( $BWS_0$ , $BWS_1$ , $BWS_2$ , $BWS_3$ ) | 0.28    | –    | 0.28    | –    | 0.28    | –    | 0.28    | –    | ns               |
| t <sub>HD</sub>                        | t <sub>KHDX</sub>                      | D <sub>[X:0]</sub> Hold after Clock (K/ $\bar{K}$ ) Rise                                                 | 0.28    | –    | 0.28    | –    | 0.28    | –    | 0.28    | –    | ns               |
| <b>Output Times</b>                    |                                        |                                                                                                          |         |      |         |      |         |      |         |      |                  |
| t <sub>CO</sub>                        | t <sub>CHQV</sub>                      | K/ $\bar{K}$ Clock Rise to Data Valid                                                                    | –       | 0.45 | –       | 0.45 | –       | 0.45 | –       | 0.45 | ns               |
| t <sub>DOH</sub>                       | t <sub>CHQX</sub>                      | Data Output Hold after Output K/ $\bar{K}$ Clock Rise (Active to Active)                                 | –0.45   | –    | –0.45   | –    | –0.45   | –    | –0.45   | –    | ns               |
| t <sub>CCQO</sub>                      | t <sub>CHCQV</sub>                     | K/ $\bar{K}$ Clock Rise to Echo Clock Valid                                                              | –       | 0.45 | –       | 0.45 | –       | 0.45 | –       | 0.45 | ns               |
| t <sub>CQOH</sub>                      | t <sub>CHCQX</sub>                     | Echo Clock Hold after K/ $\bar{K}$ Clock Rise                                                            | –0.45   | –    | –0.45   | –    | –0.45   | –    | –0.45   | –    | ns               |
| t <sub>CQD</sub>                       | t <sub>CQHCV</sub>                     | Echo Clock High to Data Valid                                                                            | –       | 0.2  | –       | 0.2  | –       | 0.2  | –       | 0.2  | ns               |
| t <sub>CQDOH</sub>                     | t <sub>CQHCV</sub>                     | Echo Clock High to Data Invalid                                                                          | –0.2    | –    | –0.2    | –    | –0.2    | –    | –0.2    | –    | ns               |
| t <sub>CQH</sub>                       | t <sub>CQHCQL</sub>                    | Output Clock (CQ/ $\bar{CQ}$ ) HIGH <sup>[26]</sup>                                                      | 0.81    | –    | 0.88    | –    | 1.03    | –    | 1.15    | –    | ns               |
| t <sub>CQH<math>\bar{CQ}</math>H</sub> | t <sub>CQH<math>\bar{CQ}</math>H</sub> | CQ Clock Rise to $\bar{CQ}$ Clock Rise <sup>[26]</sup> (rising edge to rising edge)                      | 0.81    | –    | 0.88    | –    | 1.03    | –    | 1.15    | –    | ns               |
| t <sub>CHZ</sub>                       | t <sub>CHQZ</sub>                      | Clock (K/ $\bar{K}$ ) Rise to High Z (Active to High Z) <sup>[27, 28]</sup>                              | –       | 0.45 | –       | 0.45 | –       | 0.45 | –       | 0.45 | ns               |
| t <sub>CLZ</sub>                       | t <sub>CHQX1</sub>                     | Clock (K/ $\bar{K}$ ) Rise to Low Z <sup>[27, 28]</sup>                                                  | –0.45   | –    | –0.45   | –    | –0.45   | –    | –0.45   | –    | ns               |
| t <sub>QVLD</sub>                      | t <sub>QVLD</sub>                      | Echo Clock High to QVLD Valid <sup>[29]</sup>                                                            | –0.20   | 0.20 | –0.20   | 0.20 | –0.20   | 0.20 | –0.20   | 0.20 | ns               |

### Notes

24. When a part with a maximum frequency above 300 MHz is operating at a lower clock frequency, it requires the input timings of the frequency range in which it is being operated and outputs data with the output timings of that frequency range.

25. This part has a voltage regulator internally; t<sub>POWER</sub> is the time that the power needs to be supplied above V<sub>DD</sub> minimum initially before a Read or Write operation can be initiated.

26. These parameters are extrapolated from the input timing parameters (t<sub>KH $\bar{K}$ H</sub> – 250 ps, where 250 ps is the internal jitter. An input jitter of 200 ps (t<sub>KC Var</sub>) is already included in the t<sub>KH $\bar{K}$ H</sub>). These parameters are only guaranteed by design and are not tested in production.

27. t<sub>CHZ</sub>, t<sub>CLZ</sub> are specified with a load capacitance of 5 pF as in part (b) of [AC Test Loads and Waveforms](#). Transition is measured  $\pm 100$  mV from steady state voltage.

28. At any voltage and temperature t<sub>CHZ</sub> is less than t<sub>CLZ</sub> and t<sub>CHZ</sub> less than t<sub>CO</sub>.

29. t<sub>QVLD</sub> spec is applicable for both rising and falling edges of QVLD signal.

## Switching Characteristics

Over the operating range<sup>[23, 24]</sup> (continued)

| Cypress<br>Parameter  | Consortium<br>Parameter | Description                           | 400 MHz |      | 375 MHz |      | 333 MHz |      | 300 MHz |      | Unit   |
|-----------------------|-------------------------|---------------------------------------|---------|------|---------|------|---------|------|---------|------|--------|
|                       |                         |                                       | Min     | Max  | Min     | Max  | Min     | Max  | Min     | Max  |        |
| DLL Timing            |                         |                                       |         |      |         |      |         |      |         |      |        |
| t <sub>KC Var</sub>   | t <sub>KC Var</sub>     | Clock Phase Jitter                    | –       | 0.20 | –       | 0.20 | –       | 0.20 | –       | 0.20 | ns     |
| t <sub>KC lock</sub>  | t <sub>KC lock</sub>    | DLL Lock Time (K)                     | 2048    | –    | 2048    | –    | 2048    | –    | 2048    | –    | Cycles |
| t <sub>KC Reset</sub> | t <sub>KC Reset</sub>   | K Static to DLL Reset <sup>[30]</sup> | 30      | –    | 30      | –    | 30      | –    | 30      | –    | ns     |

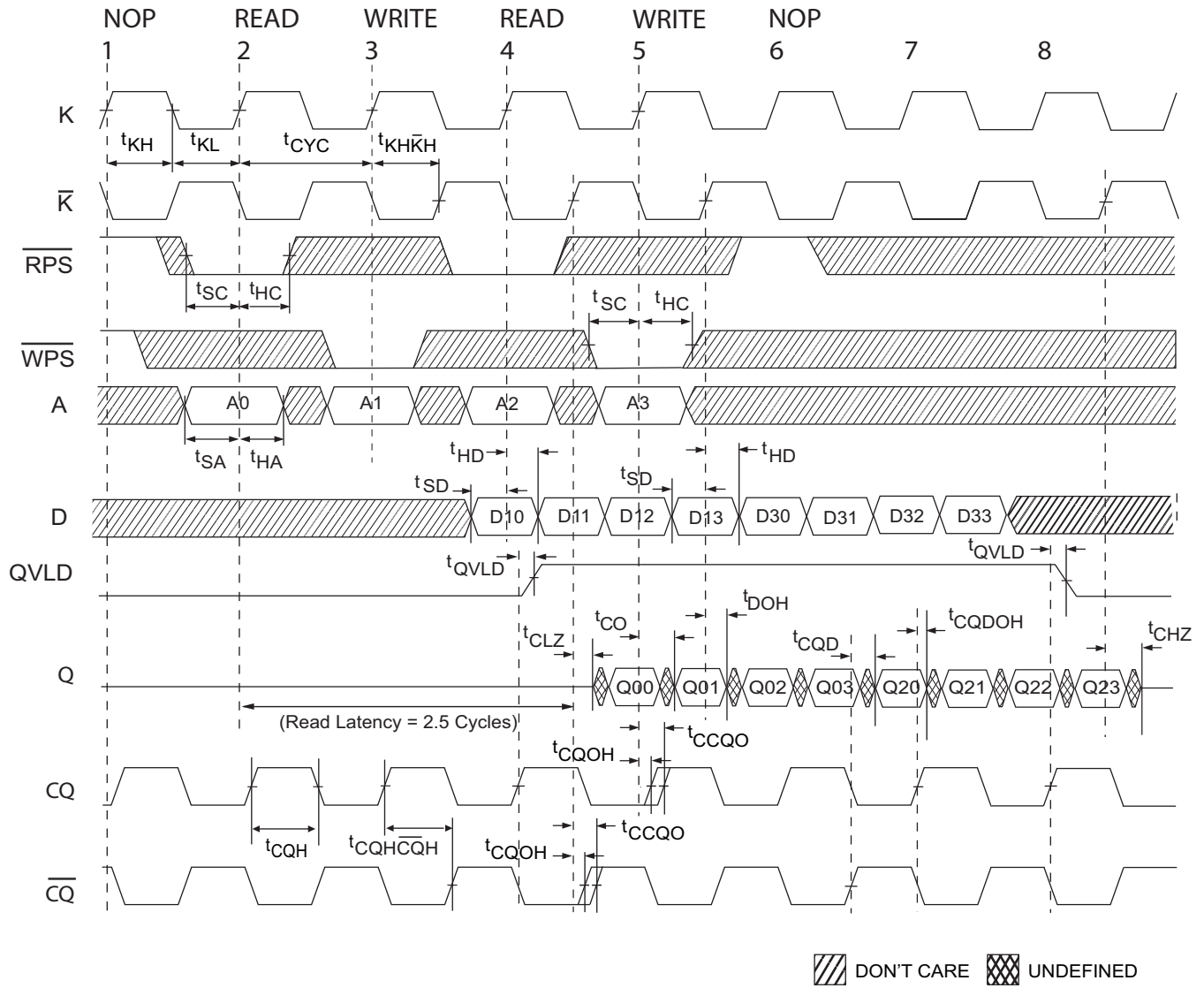
### Note

30. Hold to >V<sub>IH</sub> or <V<sub>IL</sub>.

## Switching Waveforms

### Read/Write/Deselect Sequence

Figure 6. Waveform for 2.5 Cycle Read Latency<sup>[31, 32, 33]</sup>



#### Notes

31. Q00 refers to output from address A0. Q01 refers to output from the next internal burst address following A0, i.e., A0+1.

32. Outputs are disabled (High Z) one clock cycle after a NOP.

33. In this example, if address A2 = A1, then data Q20 = D10 and Q21 = D11. Write data is forwarded immediately as read results. This note applies to the whole diagram.

## Ordering Information

Not all of the speed, package and temperature ranges are available. Contact your local sales representative or visit [www.cypress.com](http://www.cypress.com) for actual products offered.

| Speed (MHz) | Ordering Code       | Package Diagram | Package Type                                                   | Operating Range |
|-------------|---------------------|-----------------|----------------------------------------------------------------|-----------------|
| 400         | CY7C1161V18-400BZC  | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm)         | Commercial      |
|             | CY7C1176V18-400BZC  |                 |                                                                |                 |
|             | CY7C1163V18-400BZC  |                 |                                                                |                 |
|             | CY7C1165V18-400BZC  |                 |                                                                |                 |
|             | CY7C1161V18-400BZXC | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm) Pb-Free |                 |
|             | CY7C1176V18-400BZXC |                 |                                                                |                 |
|             | CY7C1163V18-400BZXC |                 |                                                                |                 |
|             | CY7C1165V18-400BZXC |                 |                                                                |                 |
|             | CY7C1161V18-400BZI  | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm)         | Industrial      |
|             | CY7C1176V18-400BZI  |                 |                                                                |                 |
|             | CY7C1163V18-400BZI  |                 |                                                                |                 |
|             | CY7C1165V18-400BZI  |                 |                                                                |                 |
|             | CY7C1161V18-400BZXI | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm) Pb-Free |                 |
|             | CY7C1176V18-400BZXI |                 |                                                                |                 |
|             | CY7C1163V18-400BZXI |                 |                                                                |                 |
|             | CY7C1165V18-400BZXI |                 |                                                                |                 |
| 375         | CY7C1161V18-375BZC  | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm)         | Commercial      |
|             | CY7C1176V18-375BZC  |                 |                                                                |                 |
|             | CY7C1163V18-375BZC  |                 |                                                                |                 |
|             | CY7C1165V18-375BZC  |                 |                                                                |                 |
|             | CY7C1161V18-375BZXC | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm) Pb-Free |                 |
|             | CY7C1176V18-375BZXC |                 |                                                                |                 |
|             | CY7C1163V18-375BZXC |                 |                                                                |                 |
|             | CY7C1165V18-375BZXC |                 |                                                                |                 |
|             | CY7C1161V18-375BZI  | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm)         | Industrial      |
|             | CY7C1176V18-375BZI  |                 |                                                                |                 |
|             | CY7C1163V18-375BZI  |                 |                                                                |                 |
|             | CY7C1165V18-375BZI  |                 |                                                                |                 |
|             | CY7C1161V18-375BZXI | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm) Pb-Free |                 |
|             | CY7C1176V18-375BZXI |                 |                                                                |                 |
|             | CY7C1163V18-375BZXI |                 |                                                                |                 |
|             | CY7C1165V18-375BZXI |                 |                                                                |                 |

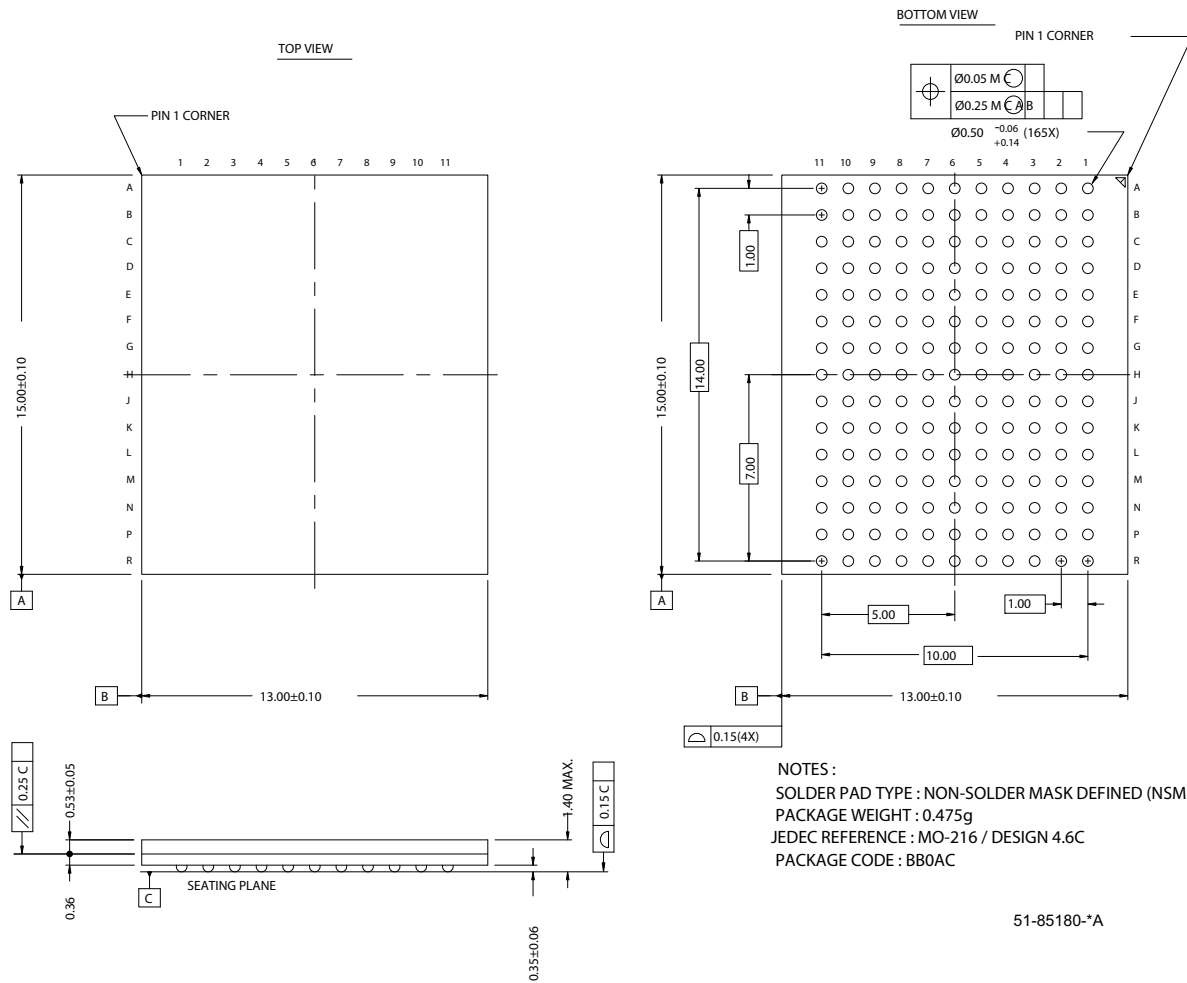
## Ordering Information (continued)

Not all of the speed, package and temperature ranges are available. Contact your local sales representative or visit [www.cypress.com](http://www.cypress.com) for actual products offered.

| Speed (MHz) | Ordering Code       | Package Diagram | Package Type                                                   | Operating Range |
|-------------|---------------------|-----------------|----------------------------------------------------------------|-----------------|
| 333         | CY7C1161V18-333BZC  | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm)         | Commercial      |
|             | CY7C1176V18-333BZC  |                 |                                                                |                 |
|             | CY7C1163V18-333BZC  |                 |                                                                |                 |
|             | CY7C1165V18-333BZC  |                 |                                                                |                 |
|             | CY7C1161V18-333BZXC | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm) Pb-Free |                 |
|             | CY7C1176V18-333BZXC |                 |                                                                |                 |
|             | CY7C1163V18-333BZXC |                 |                                                                |                 |
|             | CY7C1165V18-333BZXC |                 |                                                                |                 |
|             | CY7C1161V18-333BZI  | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm)         | Industrial      |
|             | CY7C1176V18-333BZI  |                 |                                                                |                 |
|             | CY7C1163V18-333BZI  |                 |                                                                |                 |
|             | CY7C1165V18-333BZI  |                 |                                                                |                 |
|             | CY7C1161V18-333BZXI | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm) Pb-Free |                 |
|             | CY7C1176V18-333BZXI |                 |                                                                |                 |
|             | CY7C1163V18-333BZXI |                 |                                                                |                 |
|             | CY7C1165V18-333BZXI |                 |                                                                |                 |
| 300         | CY7C1161V18-300BZC  | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm)         | Commercial      |
|             | CY7C1176V18-300BZC  |                 |                                                                |                 |
|             | CY7C1163V18-300BZC  |                 |                                                                |                 |
|             | CY7C1165V18-300BZC  |                 |                                                                |                 |
|             | CY7C1161V18-300BZXC | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm) Pb-Free |                 |
|             | CY7C1176V18-300BZXC |                 |                                                                |                 |
|             | CY7C1163V18-300BZXC |                 |                                                                |                 |
|             | CY7C1165V18-300BZXC |                 |                                                                |                 |
|             | CY7C1161V18-300BZI  | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm)         | Industrial      |
|             | CY7C1176V18-300BZI  |                 |                                                                |                 |
|             | CY7C1163V18-300BZI  |                 |                                                                |                 |
|             | CY7C1165V18-300BZI  |                 |                                                                |                 |
|             | CY7C1161V18-300BZXI | 51-85180        | 165-Ball Fine Pitch Ball Grid Array (13 x 15 x 1.4 mm) Pb-Free |                 |
|             | CY7C1176V18-300BZXI |                 |                                                                |                 |
|             | CY7C1163V18-300BZXI |                 |                                                                |                 |
|             | CY7C1165V18-300BZXI |                 |                                                                |                 |

## Package Diagram

**Figure 7. 165-Ball FBGA (13 x 15 x 1.4 mm), 51-85180**



## Document History Page

| Document Title: CY7C1161V18/CY7C1176V18/CY7C1163V18/CY7C1165V18, 18-Mbit QDR™-II+ SRAM 4-Word Burst Architecture (2.5 Cycle Read Latency)<br>Document Number: 001-06582 |         |            |                 |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------|------------|-----------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| REV.                                                                                                                                                                    | ECN No. | Issue Date | Orig. of Change | Description of Change                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| **                                                                                                                                                                      | 430351  | See ECN    | NXR             | New data sheet                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| *A                                                                                                                                                                      | 461654  | See ECN    | NXR             | Revised the MPNs from<br>CY7C1176BV18 to CY7C1176V18<br>CY7C1163BV18 to CY7C1163V18<br>CY7C1165BV18 to CY7C1165V18<br>Changed $t_{TH}$ and $t_{TL}$ from 40 ns to 20 ns, changed $t_{TMSS}$ , $t_{TDIS}$ , $t_{CS}$ , $t_{TMSH}$ , $t_{TDIH}$ , $t_{CH}$ from 10 ns to 5 ns and changed $t_{TDOV}$ from 20 ns to 10 ns in TAP AC Switching Characteristics table<br>Modified power up waveform                                                                                                                                                                                                                                                                                                   |
| *B                                                                                                                                                                      | 497629  | See ECN    | NXR             | Changed the $V_{DDQ}$ operating voltage to 1.4V to $V_{DD}$ in the Features section, in Operating Range table and in the DC Electrical Characteristics table<br>Added foot note in page 1<br>Changed the Maximum rating of Ambient Temperature with Power Applied from $-10^{\circ}\text{C}$ to $+85^{\circ}\text{C}$ to $-55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$<br>Changed $V_{REF}$ (max) spec from 0.85V to 0.95V in the DC Electrical Characteristics table and in the note below the table<br>Updated foot note 22 to specify Overshoot and Undershoot Spec<br>Updated $\Theta_{JA}$ and $\Theta_{JC}$ values<br>Removed x9 part and its related information<br>Updated footnote 25 |
| *C                                                                                                                                                                      | 1167806 | See ECN    | VKN/KKV TMP     | Converted from preliminary to final<br>Added x8 and x9 parts<br>Changed $I_{DD}$ values from 800 mA to 1080 mA for 400 MHz, 766 mA to 1020 mA for 375 MHz, 708 mA to 920 mA for 333 MHz, 663 mA to 850 mA for 300 MHz<br>Changed $I_{SB}$ values from 235 mA to 300 mA for 400 MHz, 227 mA to 290 mA for 375 MHz, 212 mA to 260 mA for 333 MHz, 201 mA to 250 mA for 300 MHz<br>Changed $t_{CYC(max)}$ spec to 8.4 ns for all speed bins<br>Changed $\Theta_{JA}$ value from 13.48 $^{\circ}\text{C/W}$ to 17.2 $^{\circ}\text{C/W}$<br>Updated Ordering Information table                                                                                                                       |
| *D                                                                                                                                                                      | 2199066 | See ECN    | VKN/AESA        | Added footnote# 22 related to $I_{DD}$                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |

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